

OPA167x 低失真音频运算放大器

1 特性

- 低噪声：1kHz 时为 $4.5\text{nV}/\sqrt{\text{Hz}}$
- 低失真：1kHz 时为 0.0001%
- 高开环增益：114dB
- 高共模抑制：110dB
- 低静态电流：
 - 每通道 2mA
- 低输入偏置电流：10pA（典型值）
- 压摆率：9V/ μs
- 宽增益带宽：16MHz ($G = 1$)
- 单位增益稳定
- 轨至轨输出
- 宽电源电压范围：
 - $\pm 2.25\text{V}$ 至 $\pm 18\text{V}$ 或 4.5V 至 36V
- 双通道和四通道版本
- 小封装尺寸：
 - 双通道：SO-8、MSOP-8、SON-8
 - 四通道：SO-14、TSSOP-14、QFN-16

2 应用

- 模拟信号调节
- 模拟和数字混频器
- 音频效果踏板
- A/V 接收器
- 车载音频系统

3 说明

OPA1678（双通道）和 OPA1679（四通道）运算放大器较音频电路中常用的传统运算放大器而言，可提供更高的系统级性能。OPA167x 放大器在 1kHz 时可实现 $4.5\text{nV}/\sqrt{\text{Hz}}$ 的低噪声密度和 0.0001% 的低失真度，从而提高了音频信号保真度。它们在 $2\text{k}\Omega$ 负载下还提供 800mV 范围内的轨至轨输出摆幅，从而增加余量并实现动态范围最大化。

OPA1678 和 OPA1679 可在 $\pm 2.25\text{V}$ 至 $\pm 18\text{V}$ （或 4.5V 至 36V）的极宽电源电压范围内工作，电源电流仅为 2mA，因此可适应许多类型的音频产品的电源限制。这些运算放大器是单位增益稳定型放大器，且可在各种负载条件下实现出色的动态行为，因此能够用于许多音频电路中。

OPA167x 放大器使用完全独立的内部电路，可将串扰降到最低，即便在过驱动或过载时也不受通道间相互作用的影响。

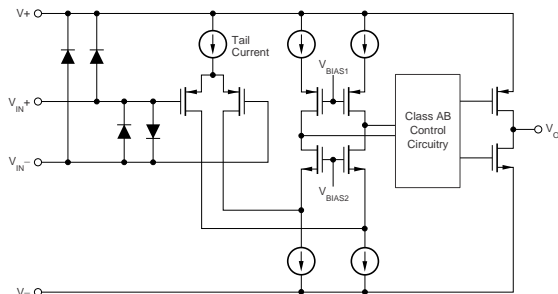
OPA167x 额定温度范围为 -40°C 至 $+85^{\circ}\text{C}$ 。

器件信息⁽¹⁾

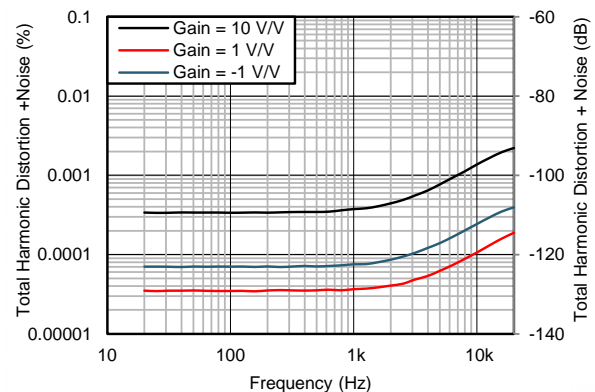
器件型号	封装	封装尺寸（标称值）
OPA1678	SOIC (8)	4.90mm × 3.91mm
	VSSOP (8)	3.00mm × 3.00mm
	SON (8)	3.00mm × 3.00mm
OPA1679	SOIC (14)	8.65mm × 3.91mm
	TSSOP (14)	5.00mm × 4.40mm
	QFN (16)	4.00mm × 4.00mm

(1) 如需了解所有可用封装，请参阅数据表末尾的封装选项附录。

简化内部原理图



THD+N 与频率（2k Ω 负载）



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4 修订历史记录

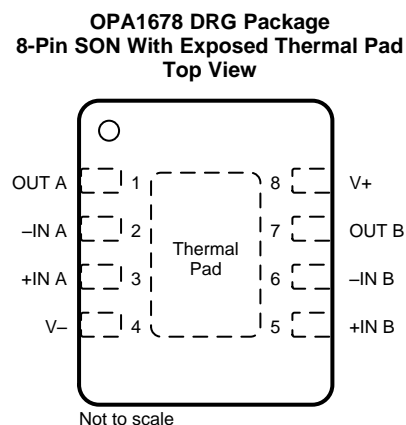
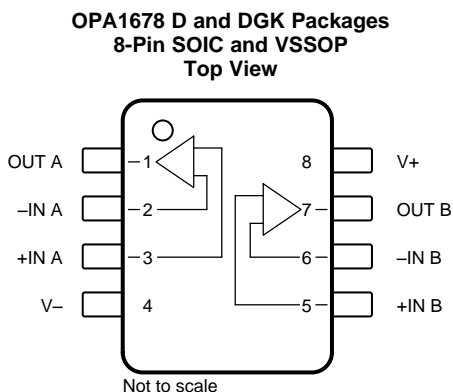
注：之前版本的页码可能与当前版本有所不同。

Changes from Revision B (June 2018) to Revision C	Page
• 已更改 将 OPA1679 QFN 封装的状态变更为生产数据	1
• Updated GPN BUF634A in 图 40	25

Changes from Revision A (May 2018) to Revision B	Page
• 添加了内容：预览 QFN (RUM) 封装	1

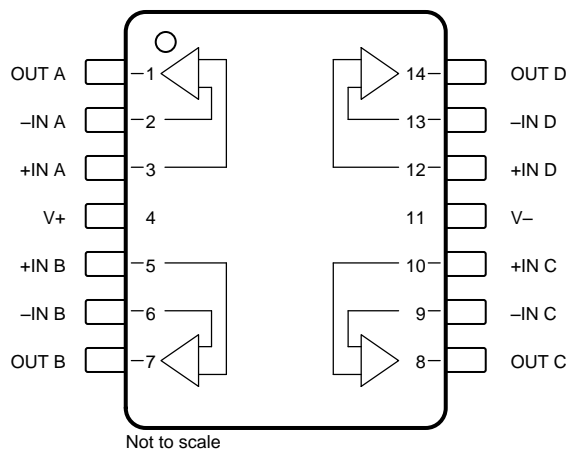
Changes from Original (February 2017) to Revision A	Page
• 已添加 在特性 列表中添加了 SON-8 封装	1
• 已添加 向器件信息 表中添加了 DRG (SON) 8 引脚封装	1
• Added DRG (SON) 8-pin pinout drawing to <i>Pin Configuration and Functions</i> section	3
• Added thermal pad information to <i>Pin Functions: OPA1678</i> table	3
• Added DRG (SON) thermal information to <i>Thermal Information: OPA1678</i> table	7

5 Pin Configuration and Functions



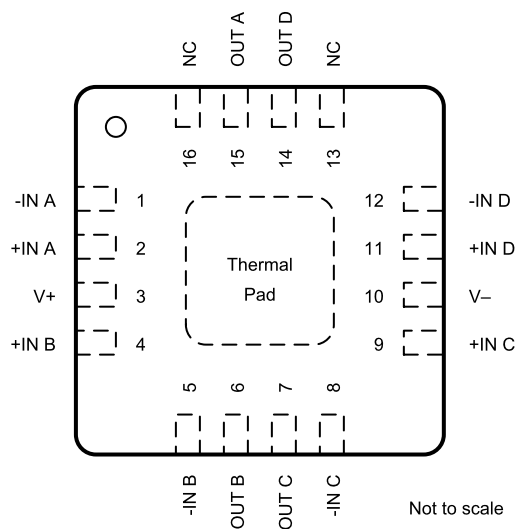
Pin Functions: OPA1678

PIN		I/O	DESCRIPTION
NAME	NO.		
-IN A	2	I	Inverting input, channel A
+IN A	3	I	Noninverting input, channel A
-IN B	6	I	Inverting input, channel B
+IN B	5	I	Noninverting input, channel B
OUT A	1	O	Output, channel A
OUT B	7	O	Output, channel B
V-	4	—	Negative (lowest) power supply
V+	8	—	Positive (highest) power supply
Thermal pad			Exposed thermal die pad on underside; connect thermal die pad to V-. Soldering the thermal pad improves heat dissipation and provides specified performance.

**OPA1679 D and PW Packages
14-Pin SOIC and TSSOP
Top View**

Pin Functions: OPA1679

PIN		I/O	DESCRIPTION
NAME	NO.		
-IN A	2	I	Inverting input, channel A
+IN A	3	I	Noninverting input, channel A
-IN B	6	I	Inverting input, channel B
+IN B	5	I	Noninverting input, channel B
-IN C	9	I	Inverting input, channel C
+IN D	10	I	Noninverting input, channel C
-IN D	13	I	Inverting input, channel D
+IN D	12	I	Noninverting input, channel D
OUT A	1	O	Output, channel A
OUT B	7	O	Output, channel B
OUT C	8	O	Output, channel C
OUT D	14	O	Output, channel D
V+	4	—	Positive (highest) power supply
V-	11	—	Negative (lowest) power supply

**OPA1679 RUM Package
16-Pin QFN With Exposed Thermal Pad
Top View**



Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
-IN A	1	I	Inverting input, channel A
+IN A	2	I	Noninverting input, channel A
-IN B	5	I	Inverting input, channel B
+IN B	4	I	Noninverting input, channel B
-IN C	8	I	Inverting input, channel C
+IN C	9	I	Noninverting input, channel C
-IN D	12	I	Inverting input, channel D
+IN D	11	I	Noninverting input, channel D
NC	13	—	No connect
NC	16	—	No connect
OUT A	15	O	Output, channel A
OUT B	6	O	Output, channel B
OUT C	7	O	Output, channel C
OUT D	14	O	Output, channel D
V+	3	—	Positive (highest) power supply
V-	10	—	Negative (lowest) power supply

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Voltage	Supply voltage, $V_S = (V+) - (V-)$		40	V
	Input	$(V-) - 0.5$	$(V+) + 0.5$	V
Current	Input (all pins except power-supply pins)	-10	10	mA
	Output short-circuit ⁽²⁾	Continuous		
Temperature	Operating, T_A	-55	125	°C
	Junction, T_J		200	°C
	Storage, T_{stg}	-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Short-circuit to $V_S / 2$ (ground in symmetrical dual-supply setups), one amplifier per package.

6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	
	Machine model (MM) ⁽³⁾	±200	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.
- (3) Machine Model was not measured on OPA1679IRUM.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
	Supply voltage	4.5 (±2.25)		36 (±18)	V
T_A	Operating temperature	-40		85	°C

6.4 Thermal Information: OPA1678

THERMAL METRIC ⁽¹⁾		OPA1678			UNIT
		D (SOIC)	DGK (VSSOP)	DRG (SON)	
		8 PINS	8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	144	219	66.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	77	79	54.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	62	104	40.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	28	15	1.9	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	61	102	40.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	10.8	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Thermal Information: OPA1679

THERMAL METRIC ⁽¹⁾		OPA1679			UNIT
		D (SOIC)	PW (TSSOP)	RUM (QFN)	
		14 PINS	14 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	90	127	38.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	55	47	34.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	44	59	17.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	20	5.5	0.6	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	44	58	17.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	7.1	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.6 Electrical Characteristics: $V_S = \pm 15\text{ V}$

at $T_A = 25^\circ\text{C}$, $R_L = 2\text{ k}\Omega$, and $V_{CM} = V_{OUT} = \text{midsupply}$, unless otherwise noted

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
AUDIO PERFORMANCE							
THD+N	Total harmonic distortion + noise			0.0001%			
		G = 1 R _L = 600 Ω f = 1 kHz V _O = 3 V _{RMS}		−120		dB	
IMD	Intermodulation distortion	G = 1 V _O = 3 V _{RMS}	SMPTE/DIN Two-Tone, 4:1 (60 Hz and 7 kHz)	0.0001%			
				−120		dB	
			DIM 30 (3-kHz square wave and 15-kHz sine wave)	0.0001%			
				−120		dB	
			CCIF Twin-Tone (19 kHz and 20 kHz)		0.0001%		
		−120		dB			
FREQUENCY RESPONSE							
GBW	Gain-bandwidth product	G = 1		16			MHz
SR	Slew rate	G = −1		9			V/μs
	Full power bandwidth ⁽¹⁾	V _O = 1 V _P		1.4			MHz
	Overload recovery time	G = −10		1			μs
	Channel separation (dual and quad)	f = 1 kHz		−130			dB
NOISE							
e _n	Input voltage noise	f = 20 Hz to 20 kHz		5.4			μV _{PP}
		f = 0.1 Hz to 10 Hz		1.74			
	Input voltage noise density	f = 1 kHz		4.5			nV/√Hz
I _n	Input current noise density	f = 1 kHz		3			fA/√Hz
OFFSET VOLTAGE							
V _{OS}	Input offset voltage	V _S = ±2.25 V to ±18 V		±0.5		±2	mV
		V _S = ±2.25 V to ±18 V T _A = −40°C to +85°C ⁽²⁾		2			μV/°C
PSRR	Power-supply rejection ratio	V _S = ±2.25 V to ±18 V		3		8	μV/V
INPUT BIAS CURRENT							
I _B	Input bias current	V _{CM} = 0 V		±10			pA
I _{OS}	Input offset current	V _{CM} = 0 V		±10			pA
INPUT VOLTAGE RANGE							
V _{CM}	Common-mode voltage range			(V−) + 0.5		(V+) − 2	V
CMRR	Common-mode rejection ratio			100		110	dB
INPUT IMPEDANCE							
	Differential			100 6			MΩ pF
	Common-mode			6000 2			GΩ pF
OPEN-LOOP GAIN							
A _{OL}	Open-loop voltage gain	(V−) + 0.8 V ≤ V _O ≤ (V+) − 0.8 V R _L = 2 kΩ		106		114	dB
OUTPUT							
V _{OUT}	Voltage output	R _L = 2 kΩ		(V−) + 0.8		(V+) − 0.8	V
I _{OUT}	Output current			See Typical Characteristics curves			mA
Z _O	Open-loop output impedance	f = 1 MHz		See Typical Characteristics curves			Ω
I _{SC}	Short-circuit current ⁽³⁾			50/−50			mA
C _{LOAD}	Capacitive load drive			100			pF

(1) Full-power bandwidth = $SR / (2\pi \times V_P)$, where SR = slew rate.

(2) Specified by design and characterization

(3) One channel at a time

Electrical Characteristics: $V_S = \pm 15\text{ V}$ (continued)

 at $T_A = 25^\circ\text{C}$, $R_L = 2\text{ k}\Omega$, and $V_{CM} = V_{OUT} = \text{midsupply}$, unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER SUPPLY						
V _S	Specified voltage		±2.25		±18	V
I _Q	Quiescent current (per channel)	I _{OUT} = 0 A		2	2.5	mA
		I _{OUT} = 0 A T _A = −40°C to +85°C ⁽²⁾			2.8	mA
TEMPERATURE						
	Specified range		−40		85	°C
	Operating range		−55		125	°C

6.7 Typical Characteristics

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, and $R_L = 2\text{ k}\Omega$, (unless otherwise noted)

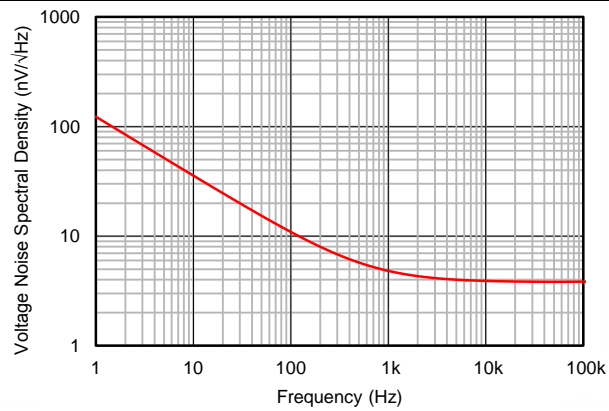


图 1. Input Voltage Noise Density vs Frequency

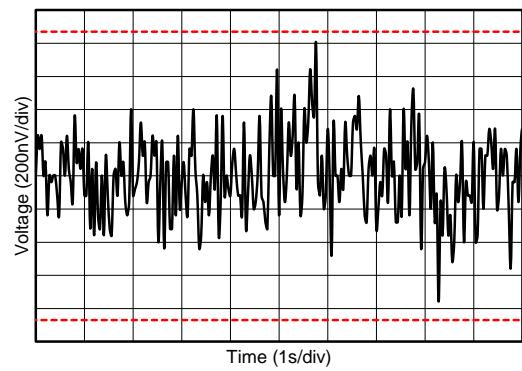


图 2. 0.1-Hz to 10-Hz Noise

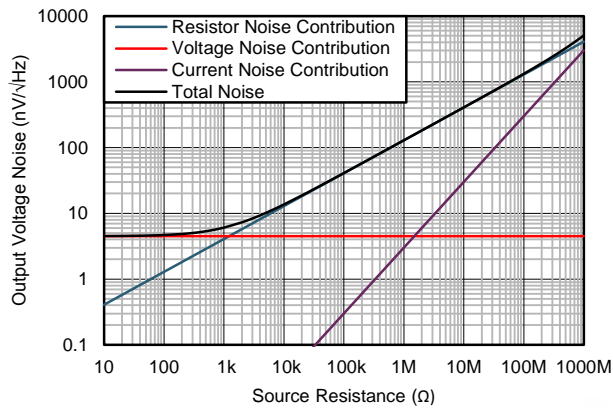


图 3. Voltage Noise vs Source Resistance

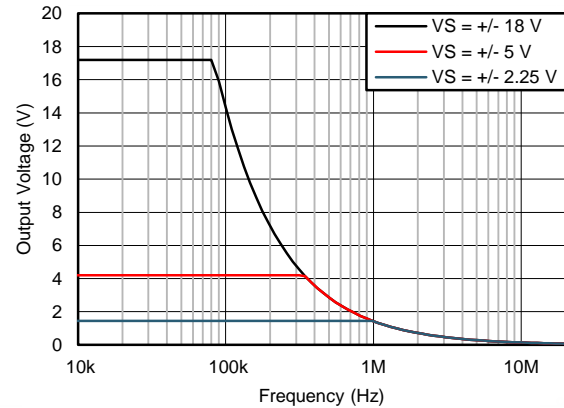


图 4. Maximum Output Voltage vs Frequency

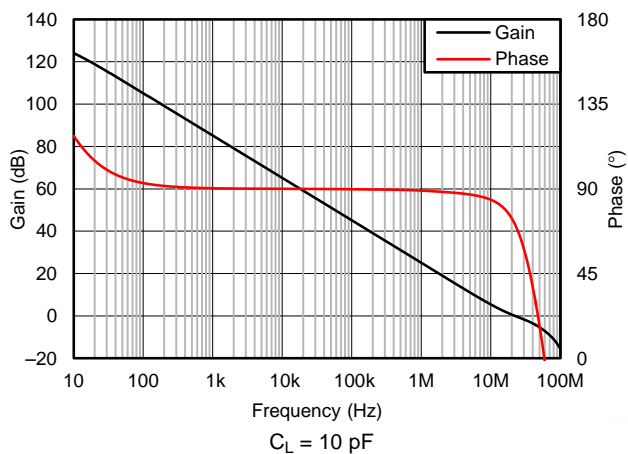


图 5. Open-Loop Gain and Phase vs Frequency

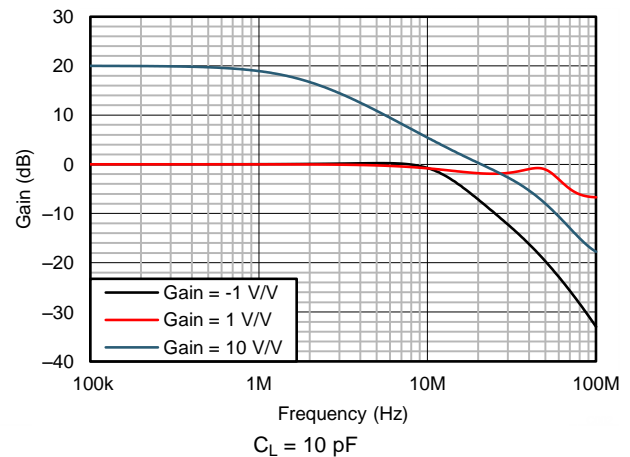


图 6. Closed-Loop Gain vs Frequency

Typical Characteristics (接下页)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, and $R_L = 2\text{ k}\Omega$, (unless otherwise noted)

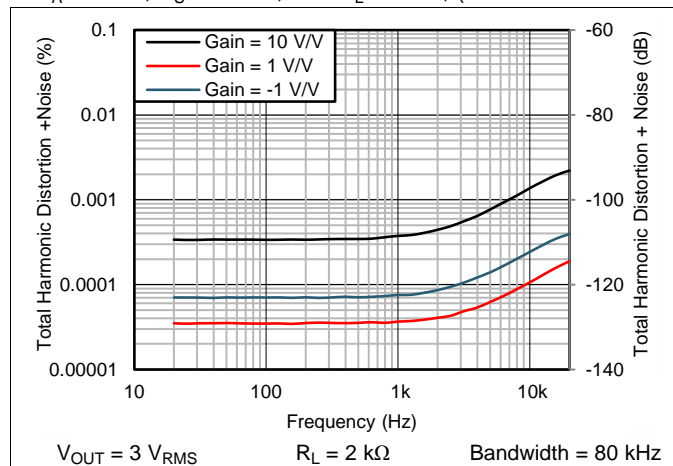


图 7. THD+N Ratio vs Frequency

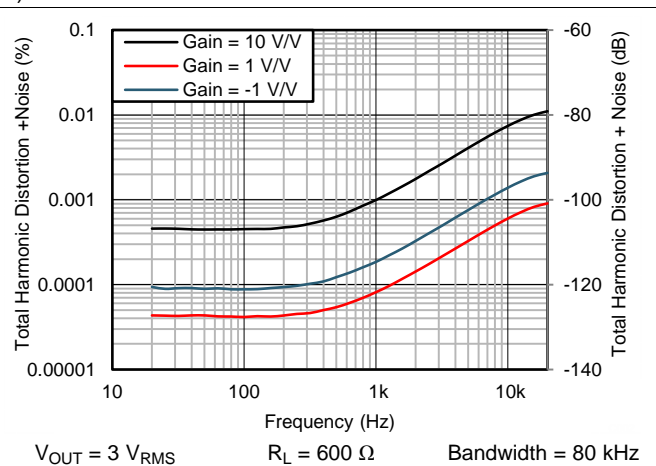


图 8. THD+N Ratio vs Frequency

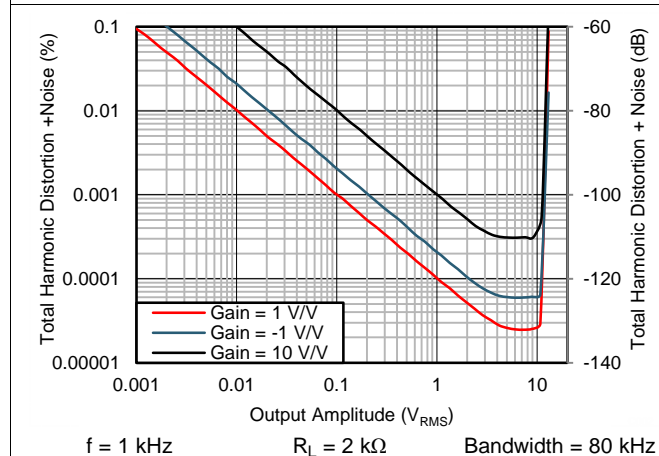


图 9. THD+N Ratio vs Output Amplitude

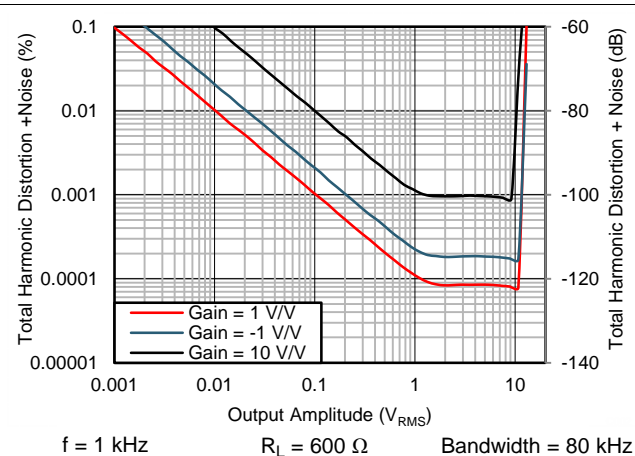


图 10. THD+N Ratio vs Output Amplitude

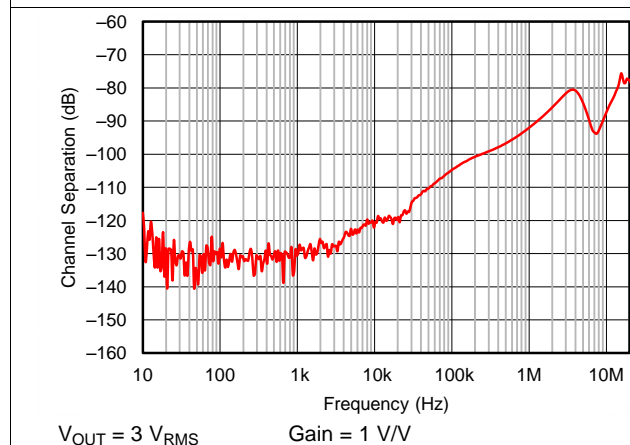


图 11. Channel Separation vs Frequency

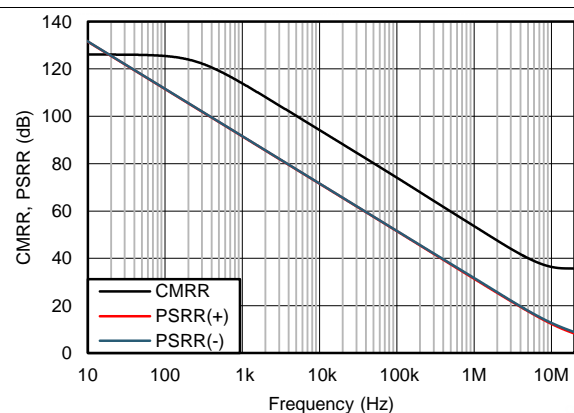
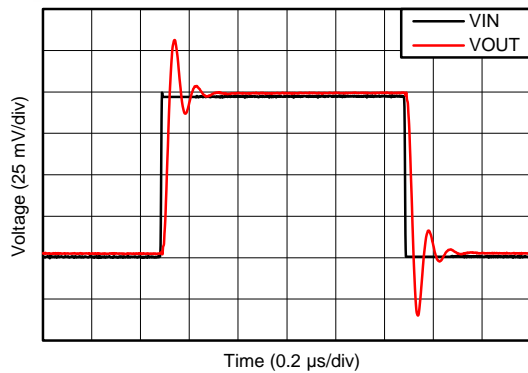


图 12. CMRR and PSRR vs Frequency
(Referred to Input)

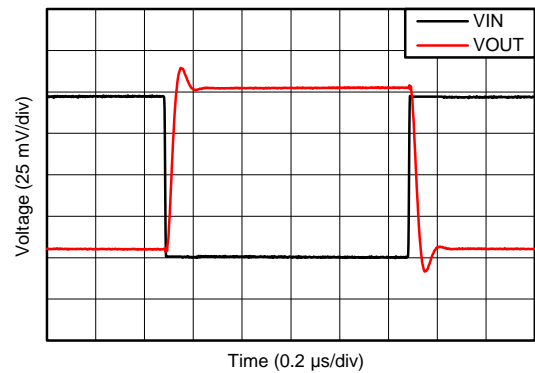
Typical Characteristics (接下页)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, and $R_L = 2\text{ k}\Omega$, (unless otherwise noted)



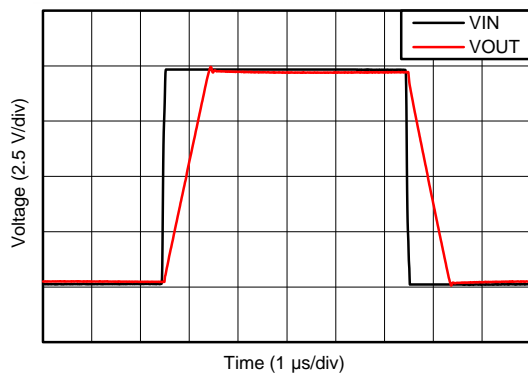
Gain = 1 V/V $C_L = 100\text{ pF}$

图 13. Small-Signal Step Response (100 mV)



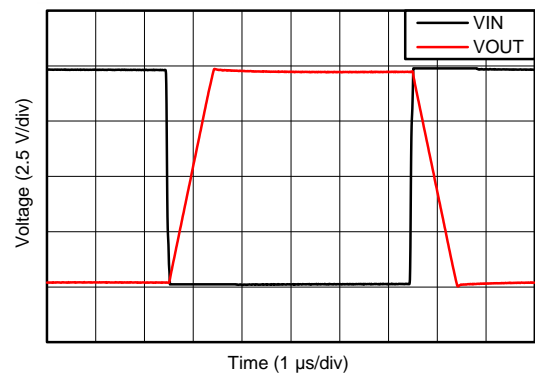
Gain = -1 V/V $C_L = 100\text{ pF}$

图 14. Small-Signal Step Response (100 mV)



Gain = +1 V/V $R_F = 2\text{ k}\Omega$ $C_L = 100\text{ pF}$

图 15. Large-Signal Step Response



Gain = -1 V/V $C_L = 100\text{ pF}$

图 16. Large-Signal Step Response

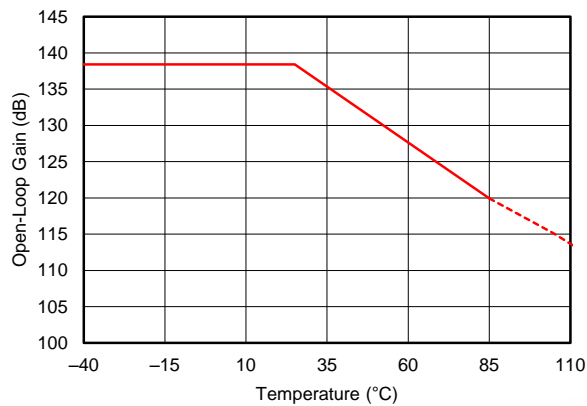


图 17. Open-Loop Gain vs Temperature

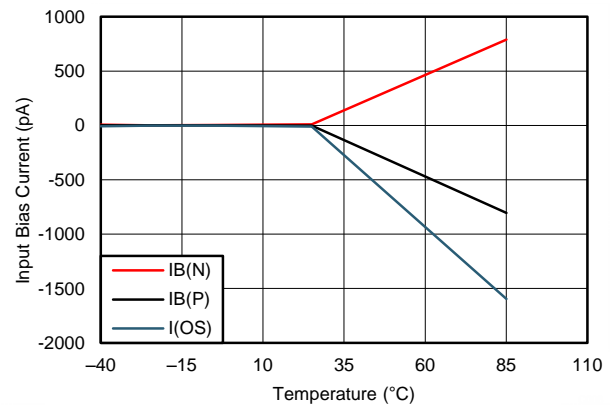


图 18. I_B and I_{OS} vs Temperature

Typical Characteristics (接下页)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, and $R_L = 2\text{ k}\Omega$, (unless otherwise noted)

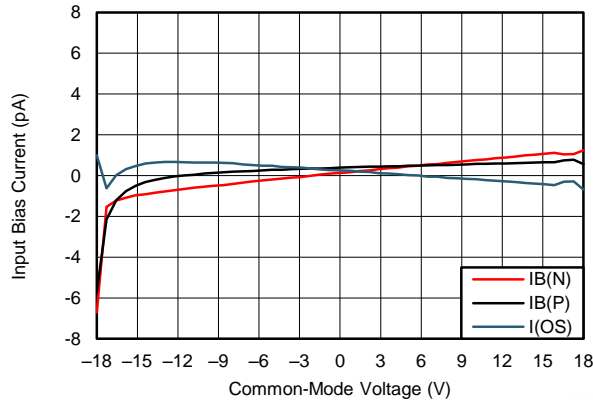


图 19. I_B and I_{OS} vs Common-Mode Voltage

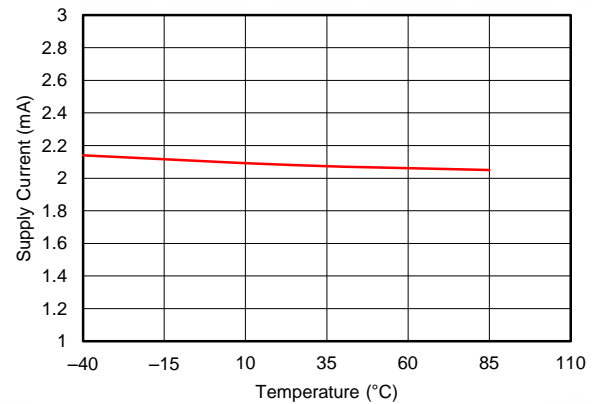


图 20. Supply Current vs Temperature

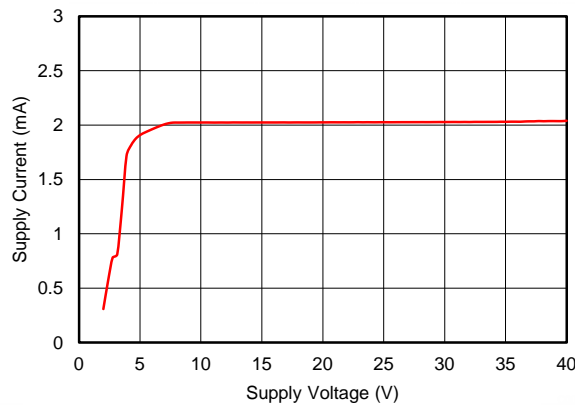


图 21. Supply Current vs Supply Voltage

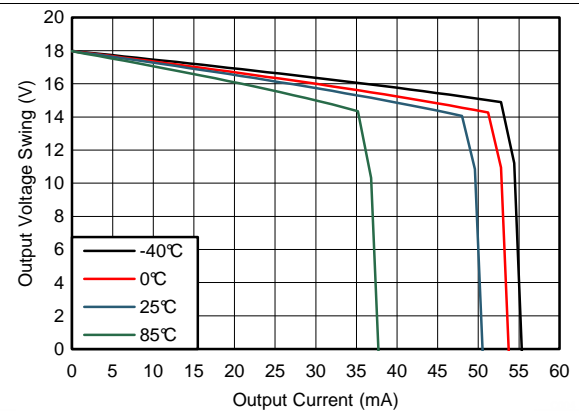


图 22. Output Voltage vs Output Current (Sourcing)

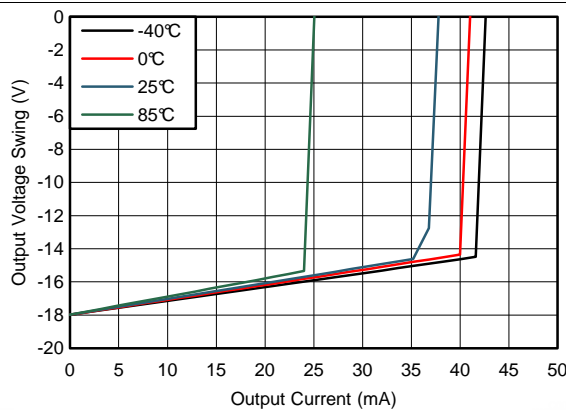


图 23. Output Voltage vs Output Current (Sinking)

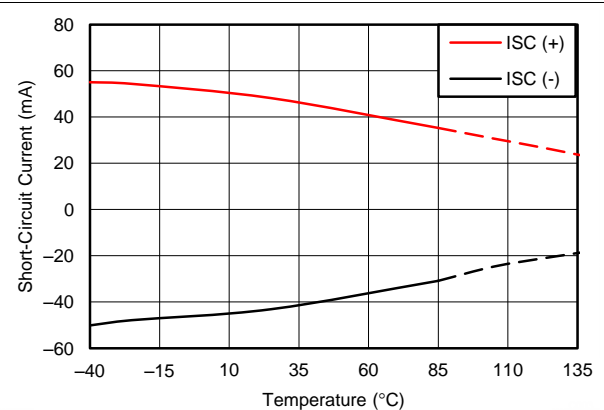


图 24. Short-Circuit Current vs Temperature

Typical Characteristics (接下页)

at $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, and $R_L = 2\text{ k}\Omega$, (unless otherwise noted)

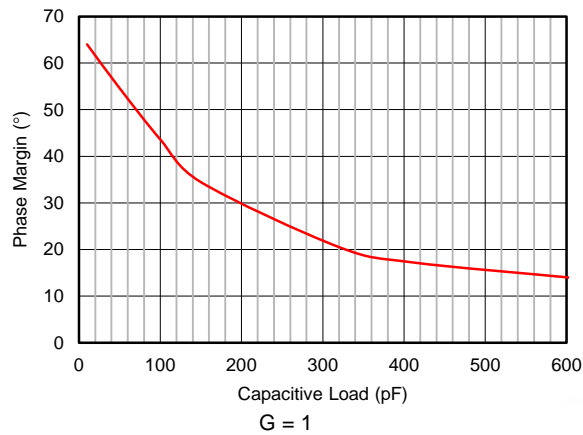


图 25. Phase Margin vs Capacitive Load

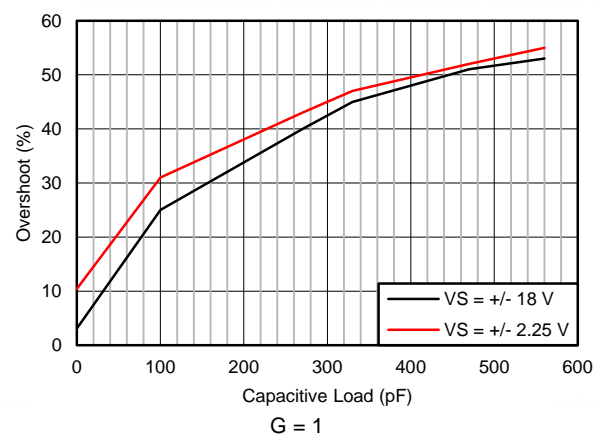


图 26. Percent Overshoot vs Capacitive Load

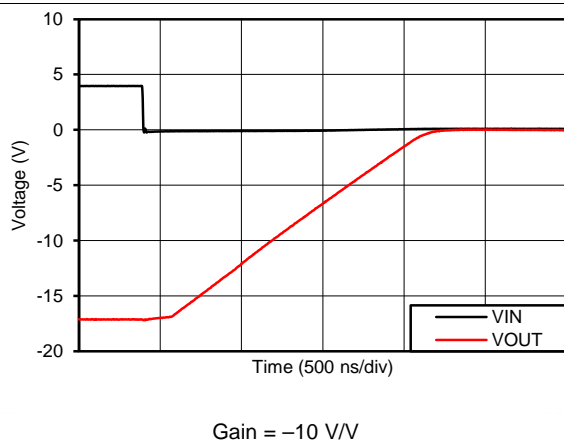


图 27. Negative Overload Recovery

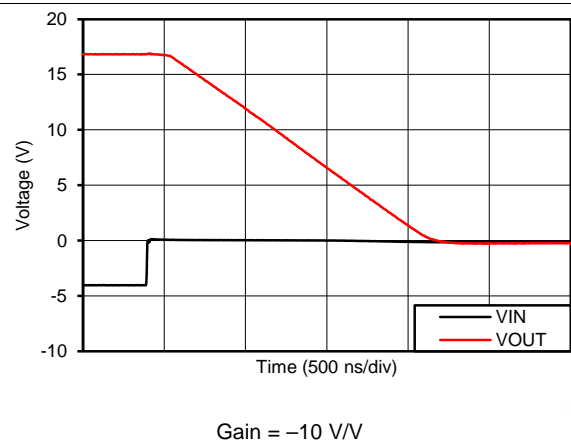


图 28. Positive Overload Recovery

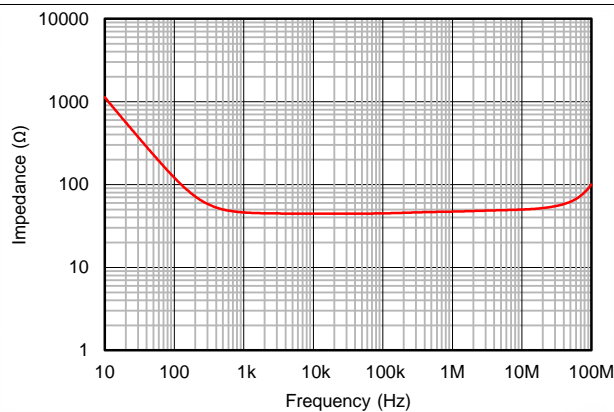


图 29. Open-Loop Output Impedance vs Frequency

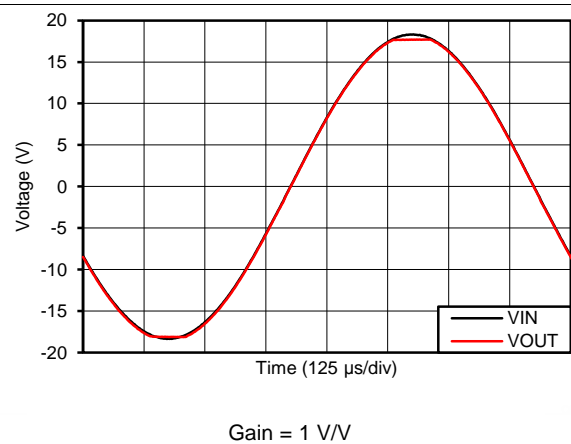


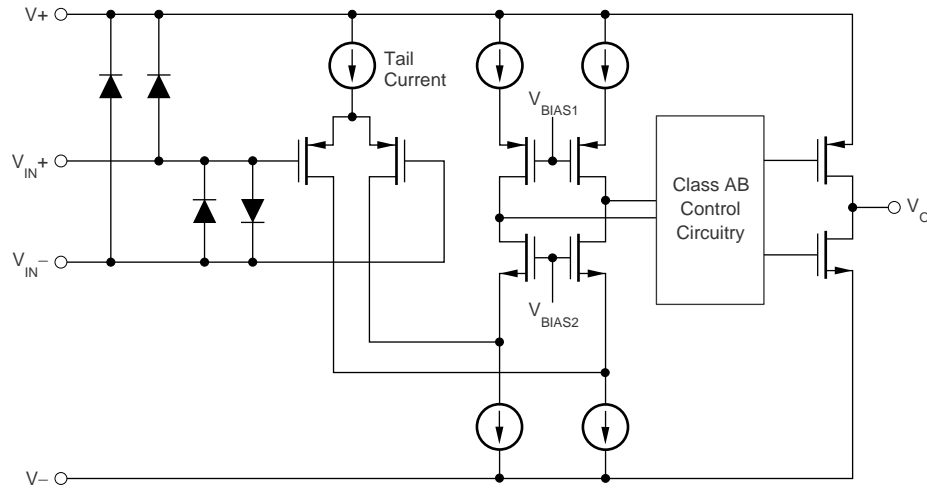
图 30. No Phase Reversal

7 Detailed Description

7.1 Overview

The OPA167x devices are unity-gain stable, dual- and quad-channel op amps with low noise and distortion. The [Functional Block Diagram](#) shows a simplified schematic of the OPA167x (one channel shown). The device consists of a low noise input stage with a folded cascode and a rail-to-rail output stage. This topology exhibits superior noise and distortion performance across a wide range of supply voltages that are not delivered by legacy commodity audio operational amplifiers.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Phase Reversal Protection

The OPA167x family has internal phase-reversal protection. Many op amps exhibit phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The input of the OPA167x prevents phase reversal with excessive common-mode voltage. Instead, the appropriate rail limits the output voltage. This performance is shown in [Figure 31](#).

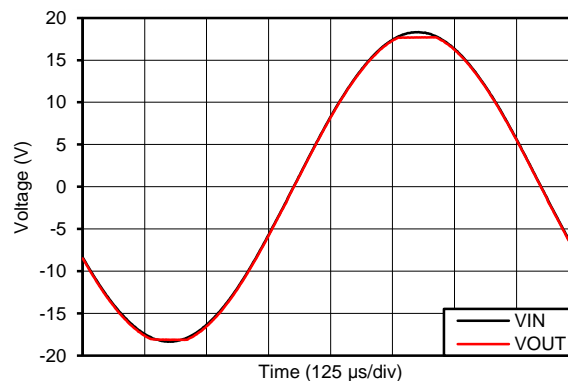


图 31. Output Waveform Devoid of Phase Reversal During an Input Overdrive Condition

Feature Description (接下页)

7.3.2 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

A good understanding of this basic ESD circuitry and the relevance to an electrical overstress event is helpful. 图 32 illustrates the ESD circuits contained in the OPA167x (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

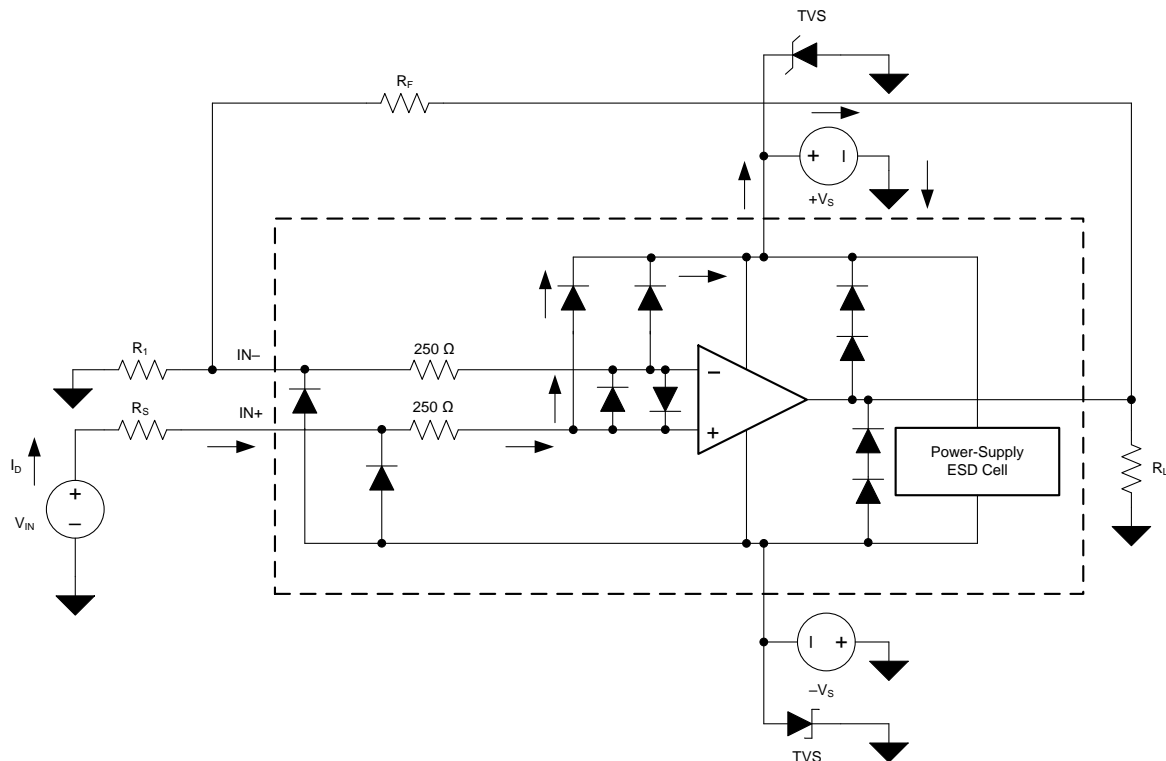


图 32. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application

An ESD event produces a short-duration, high-voltage pulse that is transformed into a short-duration, high-current pulse when discharging through a semiconductor device. The ESD protection circuits are designed to provide a current path around the operational amplifier core to prevent damage. The energy absorbed by the protection circuitry is then dissipated as heat.

When an ESD voltage develops across two or more amplifier device pins, current flows through one or more steering diodes. Depending on the path that the current takes, the absorption device can activate. The absorption device has a trigger, or threshold voltage, that is above the normal operating voltage of the OPA167x but below the device breakdown voltage level. When this threshold is exceeded, the absorption device quickly activates and clamps the voltage across the supply rails to a safe level.

When the operational amplifier connects into a circuit (see 图 32), the ESD protection components are intended to remain inactive and do not become involved in the application circuit operation. However, circumstances may arise where an applied voltage exceeds the operating voltage range of a given pin. If this condition occurs, there is a risk that some internal ESD protection circuits can turn on and conduct current. Any such current flow occurs through steering-diode paths and rarely involves the absorption device.

Feature Description (接下页)

图 32 shows a specific example where the input voltage (V_{IN}) exceeds the positive supply voltage ($V+$) by 500 mV or more. Much of what happens in the circuit depends on the supply characteristics. If $V+$ can sink the current, one of the upper input steering diodes conducts and directs current to $V+$. Excessively high current levels can flow with increasingly higher V_{IN} . As a result, the data sheet specifications recommend that applications limit the input current to 10 mA.

If the supply is not capable of sinking the current, V_{IN} can begin sourcing current to the operational amplifier and then take over as the source of positive supply voltage. The danger in this case is that the voltage can rise to levels that exceed the operational amplifier absolute maximum ratings.

Another common question involves what happens to the amplifier if an input signal is applied to the input when the power supplies ($V+$ or $V-$) are at 0 V. Again, this question depends on the supply characteristic when at 0 V, or at a level below the input signal amplitude. If the supplies appear as high impedance, then the input source supplies the operational amplifier current through the current-steering diodes. This state is not a normal bias condition; most likely, the amplifier does not operate normally. If the supplies are low impedance, then the current through the steering diodes can become quite high. The current level depends on the ability of the input source to deliver current, and any resistance in the input path.

If there is any uncertainty about the ability of the supply to absorb this current, add external Zener diodes to the supply pins; see 图 32. Select the Zener voltage so that the diode does not turn on during normal operation. However, the Zener voltage must be low enough so that the Zener diode conducts if the supply pin begins to rise above the safe-operating, supply-voltage level.

7.3.3 EMI Rejection Ratio (EMIRR)

The electromagnetic interference (EMI) rejection ratio, or EMIRR, describes the EMI immunity of operational amplifiers. An adverse effect that is common to many operational amplifiers is a change in the offset voltage as a result of RF signal rectification. An operational amplifier that is more efficient at rejecting this change in offset as a result of EMI has a higher EMIRR and is quantified by a decibel value. Measuring EMIRR can be performed in many ways, but this document provides the EMIRR IN+, which specifically describes the EMIRR performance when the RF signal is applied to the noninverting input pin of the operational amplifier. In general, only the noninverting input is tested for EMIRR for the following three reasons:

- Operational amplifier input pins are known to be the most sensitive to EMI, and typically rectify RF signals better than the supply or output pins.
- The noninverting and inverting operational amplifier inputs have symmetrical physical layouts and exhibit nearly matching EMIRR performance.
- EMIRR is easier to measure on noninverting pins than on other pins because the noninverting input pin can be isolated on a printed-circuit-board (PCB). This isolation allows the RF signal to be applied directly to the noninverting input pin with no complex interactions from other components or connecting PCB traces.

A more formal discussion of the EMIRR IN+ definition and test method is shown in the [EMI Rejection Ratio of Operational Amplifiers](#) application report, available for download at www.ti.com.

The EMIRR IN+ of the OPA167x is plotted versus frequency in 图 33. If available, any dual and quad operational amplifier device versions have approximately identical EMIRR IN+ performance. The OPA167x unity-gain bandwidth is 16 MHz. EMIRR performance below this frequency denotes interfering signals that fall within the operational amplifier bandwidth.

Feature Description (接下页)

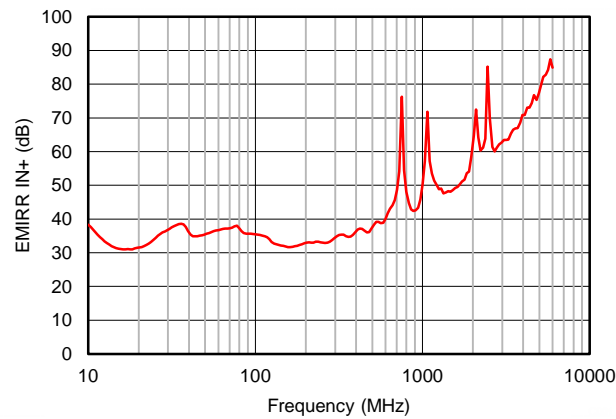


图 33. OPA167x EMIRR vs Frequency

表 1 lists the EMIRR IN+ values for the OPA167x at particular frequencies commonly encountered in real-world applications. Applications listed in 表 1 can be centered on or operated near the particular frequency shown. This information can be of special interest to designers working with these types of applications, or working in other fields likely to encounter RF interference from broad sources, such as the industrial, scientific, and medical (ISM) radio band.

表 1. OPA167x EMIRR IN+ for Frequencies of Interest

FREQUENCY	APPLICATION OR ALLOCATION	EMIRR IN+
400 MHz	Mobile radio, mobile satellite, space operation, weather, radar, UHF	36 dB
900 MHz	GSM, radio communication and navigation, GPS (to 1.6 GHz), ISM, aeronautical mobile, UHF	42 dB
1.8 GHz	GSM, mobile personal comm. broadband, satellite, L-band	52 dB
2.4 GHz	802.11b/g/n, Bluetooth™, mobile personal comm., ISM, amateur radio and satellite, S-band	64 dB
3.6 GHz	Radiolocation, aero comm./nav., satellite, mobile, S-band	67 dB
5 GHz	802.11a/n, aero communication and navigation, mobile communication, space and satellite operation, C-band	77 dB

7.3.3.1 EMIRR IN+ Test Configuration

图 34 shows the circuit configuration for testing the EMIRR IN+. An RF source is connected to the operational amplifier noninverting input pin using a transmission line. The operational amplifier is configured in a unity-gain buffer topology with the output connected to a low-pass filter (LPF) and a digital multimeter (DMM). A large impedance mismatch at the operational amplifier input causes a voltage reflection; however, this effect is characterized and accounted for when determining the EMIRR IN+. The resulting dc offset voltage is sampled and measured by the multimeter. The LPF isolates the multimeter from residual RF signals that can interfere with multimeter accuracy. See the [EMI Rejection Ratio of Operational Amplifiers](#) application report for more details.

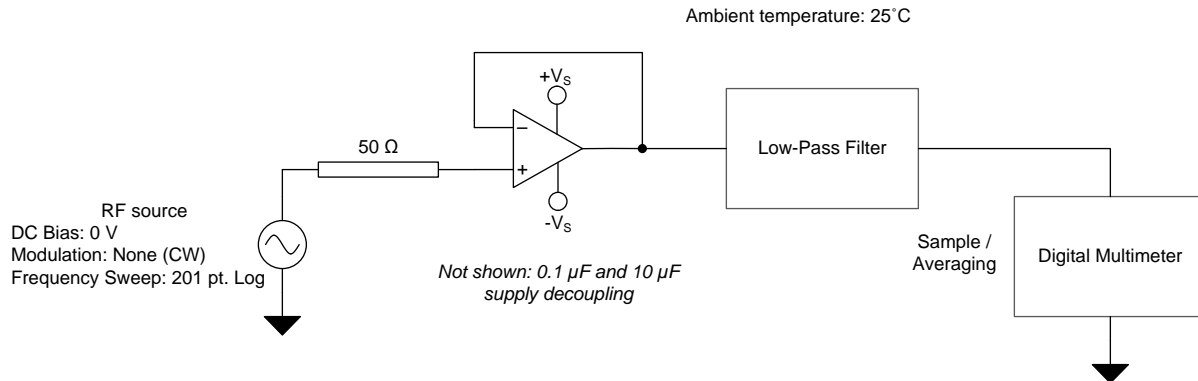


图 34. EMIRR IN+ Test Configuration Schematic

7.4 Device Functional Modes

7.4.1 Operating Voltage

The OPA167x series op amps operate from ± 2.25 V to ± 18 V supplies while maintaining excellent performance. The OPA167x series can operate with as little as 4.5 V between the supplies and with up to 36 V between the supplies. However, some applications do not require equal positive and negative output voltage swing. With the OPA167x series, power-supply voltages are not required to be equal. For example, the positive supply can be set to 25 V with the negative supply at -5 V.

In all cases, the common-mode voltage must be maintained within the specified range. In addition, key parameters are ensured over the specified temperature range of $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$. Parameters that vary significantly with operating voltage or temperature are shown in the [Typical Characteristics](#) section.

8 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Capacitive Loads

The dynamic characteristics of the OPA167x series are optimized for commonly encountered gains, loads, and operating conditions. The combination of low closed-loop gain and high capacitive loads decreases the phase margin of the amplifier and can lead to gain peaking or oscillations. As a result, heavier capacitive loads must be isolated from the output. The simplest way to achieve this isolation is to add a small resistor (R_S equal to 50 Ω , for example) in series with the output.

This small series resistor also prevents excess power dissipation if the output of the device becomes shorted. For more details about analysis techniques and application circuits, see the [Feedback Plots Define Op Amp AC Performance](#) application report, available for download from the TI website (www.ti.com).

8.2 Typical Application

Contact microphones are useful for amplifying the sound of musical instruments which do not contain electrical pickups, such as acoustic guitars and violins. Most contact microphones use a piezo element to convert vibrations in the body of the musical instrument to a voltage which may be amplified or recorded. The low noise and low input bias current of the OPA1678 make the device an excellent choice for high impedance preamplifiers for piezo elements. This preamplifier circuit provides high input impedance for the piezo element but has low output impedance for driving long cable runs. The circuit is also designed to be powered from 48-V phantom power which is commonly available in professional microphone preamplifiers and recording consoles.

A TINA-TI™ simulation schematic of the circuit below is available in the *Tools and Software* section of the OPA167x [product folder](#).

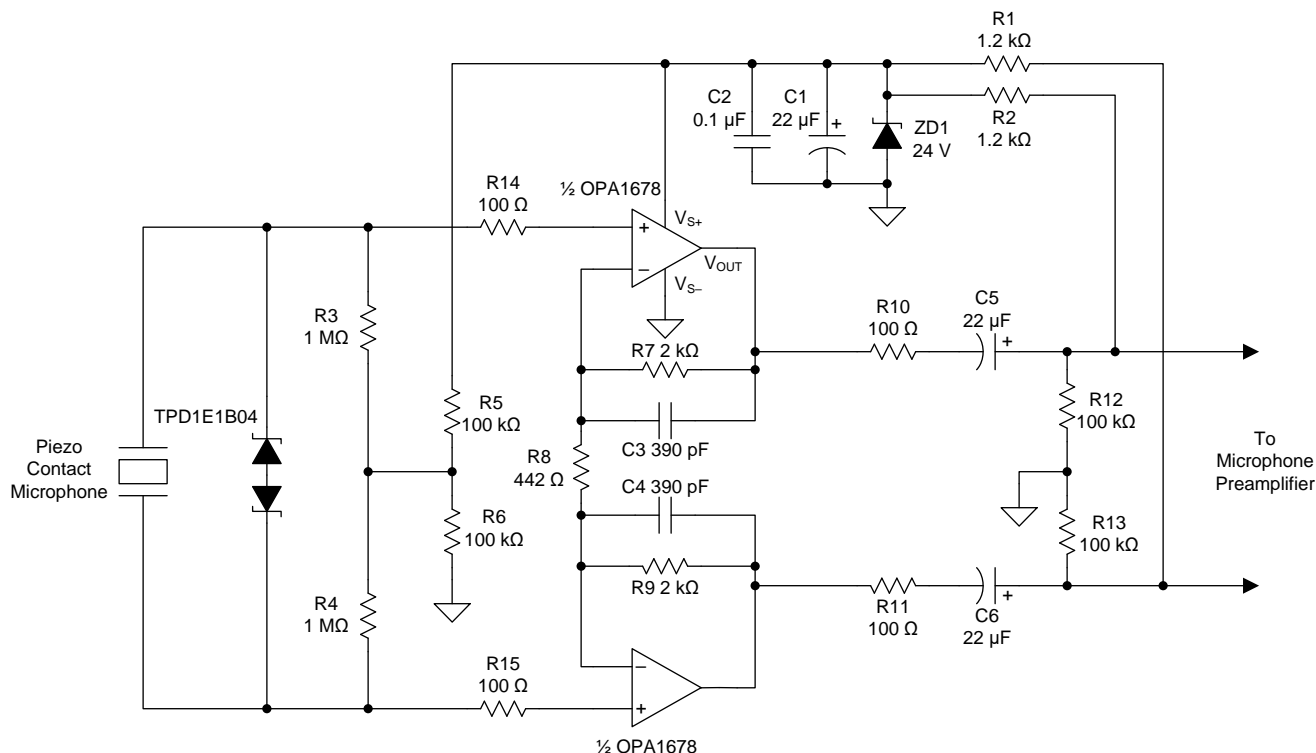


图 35. Phantom-Powered Preamplifier for Piezo Contact Microphones

8.2.1 Design Requirements

- –3-dB Bandwidth: 20 Hz to 20 kHz
- Gain: 20 dB (10 V/V)
- Piezo Element Capacitance: 8 nF (9-kHz resonance)

Typical Application (接下页)

8.2.2 Detailed Design Procedure

8.2.2.1 Power Supply

In professional audio systems, phantom power is applied to the two signal lines that carry a differential audio signal from the microphone. 图 36 is a diagram of the system showing 48-V phantom power applied to the differential signal lines between the piezo preamplifier output and the input of a professional microphone preamplifier.

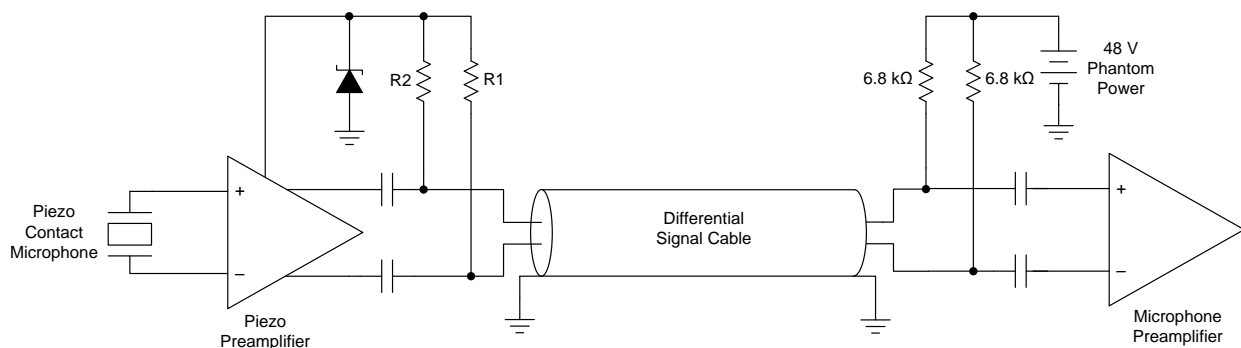


图 36. System Diagram Showing the Application of Phantom Power to the Audio Signal Lines

A voltage divider is used to extract the common-mode phantom power from the differential audio signal in this type of system. The voltage at center point of the voltage divider formed by R1 and R2 does not change when audio signals are present on the signal lines (assuming R1 and R2 are matched). A Zener diode forces the voltage at the center point of R1 and R2 to a regulated voltage. The values of R1 and R2 are determined by the allowable voltage drop across these resistors from the current delivered to both op amp channels and the Zener diode. There are two power supply current pathways in parallel, each sharing half the total current of the op amp and Zener diode. Resistors R1 and R2 can be calculated using Equation 1:

$$R_1 = R_2 = R_{PS}$$

$$\frac{V_{ZD}}{\left(\frac{I_{OPA}}{2} + \frac{I_{ZD}}{2}\right)} - 6.8 \text{ k}\Omega = R_{PS} \quad (1)$$

A 24-V Zener diode is selected for this design, and 1 mA of current flows through the diode at idle conditions to maintain the reverse-biased condition of the Zener. The maximum idle power supply current of both op amp channels is 5 mA. Inserting these values into 公式 1 gives the values for R1 and R2 shown in Equation 2.

$$\frac{24\text{V}}{\left(\frac{I_{OPA}}{2} + \frac{I_{ZD}}{2}\right)} - 6.8 \text{ k}\Omega = \frac{24\text{V}}{\left(\frac{5.0 \text{ mA}}{2} + \frac{1.0 \text{ mA}}{2}\right)} - 6.8 \text{ k}\Omega = 1.2 \text{ k}\Omega = R_{PS} \quad (2)$$

Using a value of 1.2 kΩ for resistors R1 and R2 establishes a 1-mA current through the Zener diode and properly regulate the node to 24 V. Capacitor C1 forms a low-pass filter with resistors R1 and R2 to filter the Zener diode noise and any residual differential audio signals. Mismatch in the values of R1 and R2 causes a portion of the audio signal to appear at the voltage divider center point. The corner frequency of the low-pass filter must be set below the audio band, as shown in Equation 3.

$$C_1 \geq \frac{1}{2 \cdot \pi \cdot R_1 \parallel R_2 \cdot f_{-3dB}} \geq \frac{1}{2 \cdot \pi \cdot 600 \Omega \cdot 20 \text{ Hz}} \geq 13 \mu\text{F} \rightarrow 22 \mu\text{F} \quad (3)$$

A 22-μF capacitor is selected because the capacitor meets the requirements for power supply filtering and is a widely available denomination. A 0.1-μF capacitor (C2) is added in parallel with C1 as a high-frequency bypass capacitor.

Typical Application (接下页)

8.2.2.2 Input Network

Resistors R3 and R4 provide a pathway for the input bias current of the OPA1678 while maintaining the high input impedance of the circuit. The contact microphone capacitance and the required low-frequency response determine the values of R3 and R4. The –3-dB frequency formed by the microphone capacitance and amplifier input impedance is shown in [Equation 4](#):

$$F_{-3dB} = \frac{1}{2 \cdot \pi \cdot (R_3 + R_4) \cdot C_{MIC}} \leq 20 \text{ Hz} \quad (4)$$

A piezo element with 8 nF of capacitance was selected for this design because the 9-kHz resonance is towards the upper end of the audible bandwidth, and is less likely to affect the frequency response of many musical instruments. The minimum value for resistors R3 and R4 is then calculated with [Equation 5](#):

$$R_3 = R_4 = R_{IN}$$

$$R_{IN} \geq \frac{1}{4 \cdot \pi \cdot F_{-3dB} \cdot C_{MIC}} \geq \frac{1}{4 \cdot \pi \cdot 20 \text{ Hz} \cdot 8 \text{ nF}} \geq 497.4 \text{ k}\Omega \quad (5)$$

1-M Ω resistors are selected for R3 and R4 to ensure the circuit meets the design requirements for –3-dB bandwidth. The center point of resistors R3 and R4 is biased to half the supply voltage through the voltage divider formed by R5 and R6. This sets the input common-mode voltage of the circuit to a value within the input voltage range of the OPA1678. Piezo elements can produce very large voltages if the elements are struck with sufficient force. To prevent damage, the input of the OPA1678 is protected by a transient voltage suppressor (TVS) diode placed across the preamplifier inputs. The TPD1E1B04 TVS was selected due to low capacitance and the 6.4-V clamping voltage does not clamp the desired low amplitude vibration signals. Resistors R14 and R15 limit current flow into the amplifier inputs in the event that the internal protection diodes of the amplifier are forward-biased.

8.2.2.3 Gain

R7, R8, and R9 determines the gain of the preamplifier circuit. The gain of the circuit is shown in [Equation 6](#):

$$A_V = 1 + \frac{R_7 + R_9}{R_8} = 10 \text{ V/V} \quad (6)$$

Resistors R7 and R9 are selected with a value of 2 k Ω to avoid loading the output of the OPA1678 and producing distortion. The value of R8 is then calculated in [Equation 7](#):

$$R_8 = \frac{R_7 + R_9}{A_V - 1} = \frac{2 \text{ k}\Omega + 2 \text{ k}\Omega}{10 - 1} = 444.4 \text{ }\Omega \rightarrow 442 \text{ }\Omega \quad (7)$$

Capacitors C3 and C4 limit the bandwidth of the circuit so that signals outside the audio bandwidth are not amplified. The corner frequency produced by capacitors C3 and C4 is shown in [Equation 8](#). This corner frequency must be above the desired –3-dB bandwidth point to avoid attenuating high frequency audio signals.

$$C_3 = C_4 = C_{FB}$$

$$C_{FB} \leq \frac{1}{2 \cdot \pi \cdot F_{-3dB} \cdot R_{7/9}} \leq \frac{1}{2 \cdot \pi \cdot 20 \text{ kHz} \cdot 2 \text{ k}\Omega} \leq 3.98 \text{ nF} \quad (8)$$

390-pF capacitors are selected for C3 and C4, which places the corner frequency approximately 1 decade above the desired –3-dB bandwidth point. Capacitors C3 and C4 must be NP0 or C0G type ceramic capacitors or film capacitors. Other ceramic dielectrics, such as X7R, are not suitable for these capacitors and produces distortion.

Typical Application (接下页)

8.2.2.4 Output Network

The audio signal is AC-coupled onto the microphone signal lines through capacitors C5 and C6. The value of capacitors C5 and C6 are determined by the low-frequency design requirements and the input impedance of the microphone preamplifier that connect to the output of the circuit. 公式 9 shows an approximation of the capacitor value requirements, and neglects the effects of R10, R11, R12, and R13 on the frequency response. The microphone preamplifier input impedance (R_{IN_MIC}) uses a typical value of 4.4 k Ω for the calculation.

$$C_5 = C_6 = C_{OUT}$$

$$C_{OUT} \geq \frac{2}{2 \cdot \pi \cdot R_{IN_MIC} \cdot 20 \text{ Hz}} \geq \frac{2}{2 \cdot \pi \cdot 4.4 \text{ k}\Omega \cdot 20 \text{ Hz}} \geq 3.6 \mu\text{F} \quad (9)$$

For simplicity, the same 22- μF capacitors selected for the power supply filtering are selected for C5 and C6 to satisfy 公式 9. At least 50-V rated capacitors must be used for C5 and C6. If polarized capacitors are used, the positive terminal must be oriented towards the microphone preamplifier. Resistors R10 and R11 isolate the op amp outputs from the capacitances of long cables which may cause instability. R12 and R13 discharge AC-coupling capacitors C4 and C5 when phantom power is removed.

8.2.3 Application Curves

The frequency response of the preamplifier circuit is shown in 图 37. The -3-dB frequencies are 15.87 Hz and 181.1 kHz which meet the design requirements. The gain within the passband of the circuit is 18.9 dB, slightly below the design goal of 20 dB. The reduction in gain is a result of the voltage division between the output resistors of the piezo preamplifier circuit and the input impedance of the microphone preamplifier. The A-weighted noise of the circuit (referred to the input) is 842.2 nV_{RMS} or -119.27 dBu.

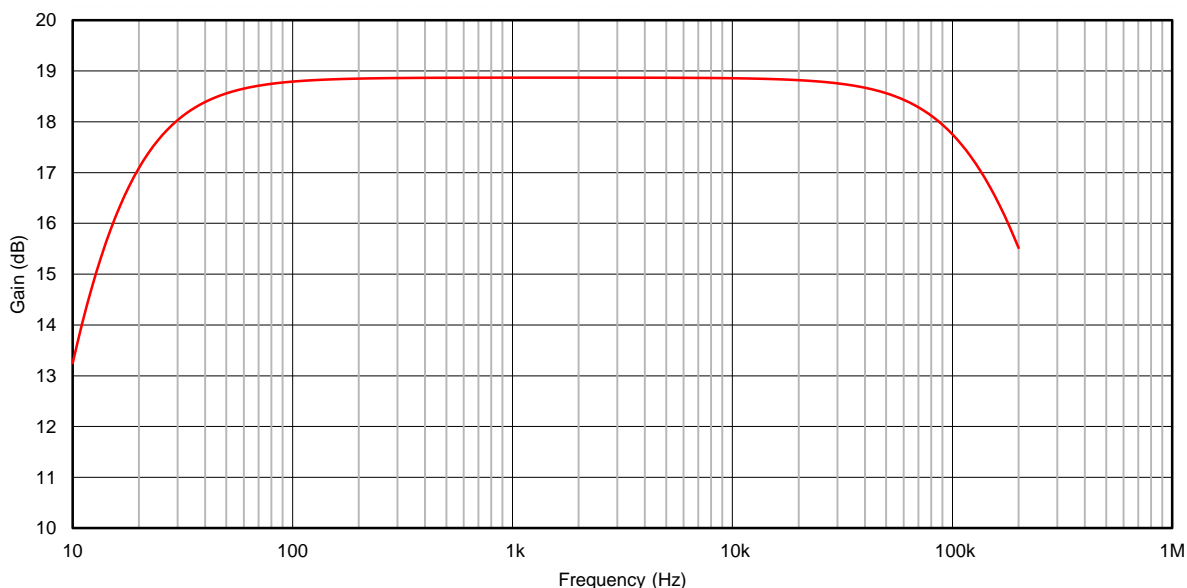


图 37. Frequency Response of the Preamplifier Circuit for a 8-nF Piezo Element

8.2.4 Other Applications

The low noise and distortion of the OPA167x series make the devices designed for a variety of applications in professional and consumer audio products. The examples shown here are possible applications where the OPA167x provides exceptional performance.

Typical Application (接下页)

8.2.4.1 Phono Preamplifier for Moving Magnet Cartridges

The noise and distortion performance of the OPA167x family of amplifiers is exceptional in applications with high source impedances, which makes these devices a viable choice in preamplifier circuits for moving magnet (MM) phono cartridges. 图 38 shows a preamplifier circuit for MM cartridges with 40 dB of gain at 1 kHz.

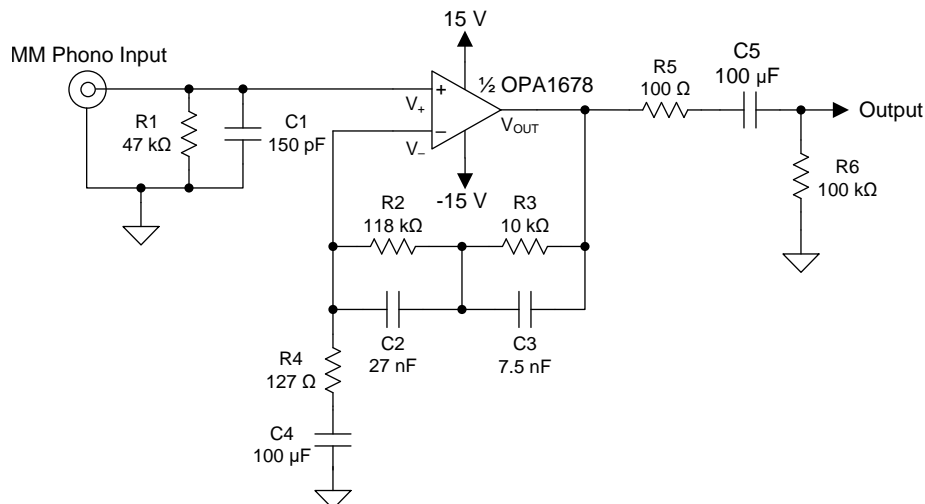


图 38. Phono Preamplifier for Moving Magnet Cartridges (Single-Channel Shown)

8.2.4.2 Single-Supply Electret Microphone Preamplifier

The preamplifier circuit shown in 图 39 operates the OPA1678 as a transimpedance amplifier that converts the output current from the electret microphone's internal JFET into a voltage. Resistor R4 determines the gain of the circuit. Resistors R2 and R3 bias the input voltage to half the power supply voltage for proper functionality on a single-supply.

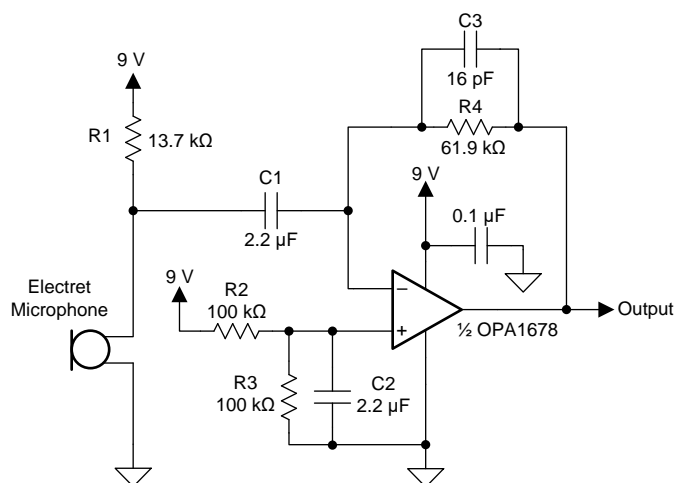


图 39. Single-Supply Electret Microphone Preamplifier

8.2.4.3 Composite Headphone Amplifier

图 40 shows the BUF634A buffer inside the feedback loop of the OPA1678 to increase the available output current for low-impedance headphones. If the BUF634A is used in wide-bandwidth mode, no additional components besides the feedback resistors are required to maintain loop stability.

Typical Application (接下页)

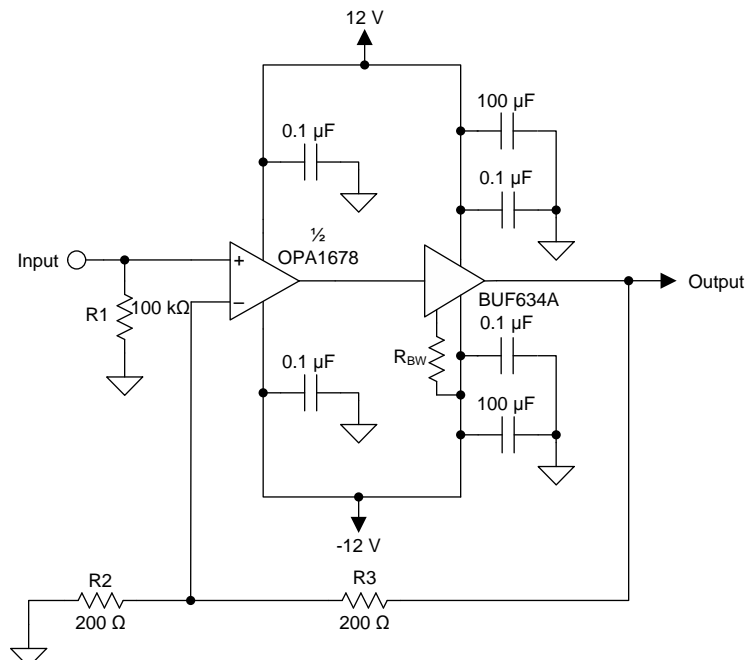


图 40. Composite Headphone Amplifier (Single-Channel Shown)

8.2.4.4 Differential Line Receiver With AC-Coupled Outputs

图 41 shows the OPA1678 used as an integrator that drives the reference pin of the INA1650, which forces the output DC voltage to 0 V. This configuration is an alternative to large AC-coupling capacitors which can distort at high output levels. The low input bias current and low input offset voltage of the OPA1678 make the device designed for integrator applications.

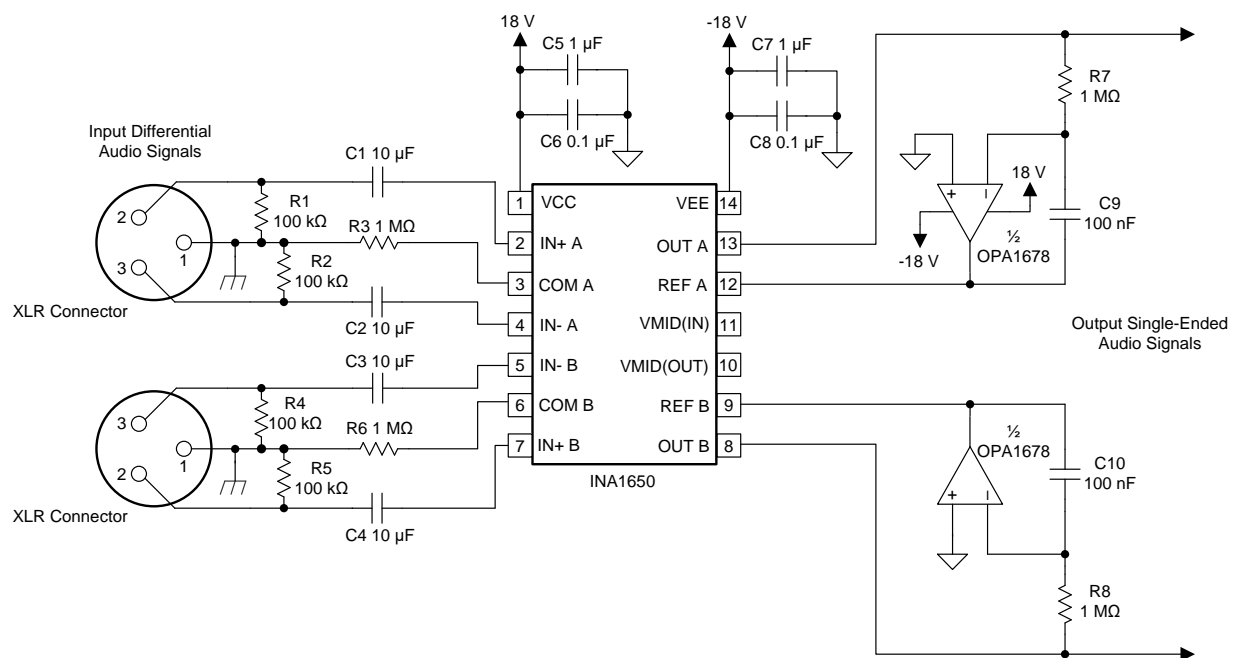


图 41. Differential Line Receiver With AC-Coupled Outputs

9 Power Supply Recommendations

The OPA167x devices are specified for operation from 4.5 V to 36 V (± 2.25 V to ± 18 V); many specifications apply from -40°C to $+85^{\circ}\text{C}$. Parameters that can exhibit significant variance with regard to operating voltage or temperature are shown in the [Typical Characteristics](#) section. Applications with noisy or high-impedance power supplies require decoupling capacitors close to the device pins. In most cases, 0.1- μF capacitors are adequate.

10 Layout

10.1 Layout Guidelines

For best operational performance of the device, use good printed-circuit board (PCB) layout practices, including:

- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and of op amp itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1- μF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from $V+$ to ground is applicable for single-supply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces electromagnetic interference (EMI) noise pickup. Physically separate digital and analog grounds, observing the flow of the ground current.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As shown in [Figure 42](#), keeping R_F and R_G close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Cleaning the PCB following board assembly is recommended for best performance.
- Any precision integrated circuit can experience performance shifts resulting from moisture ingress into the plastic package. Following any aqueous PCB cleaning process, TI recommends baking the PCB assembly to remove moisture introduced into the device packaging during the cleaning process. A low temperature, post-cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.

10.2 Layout Example

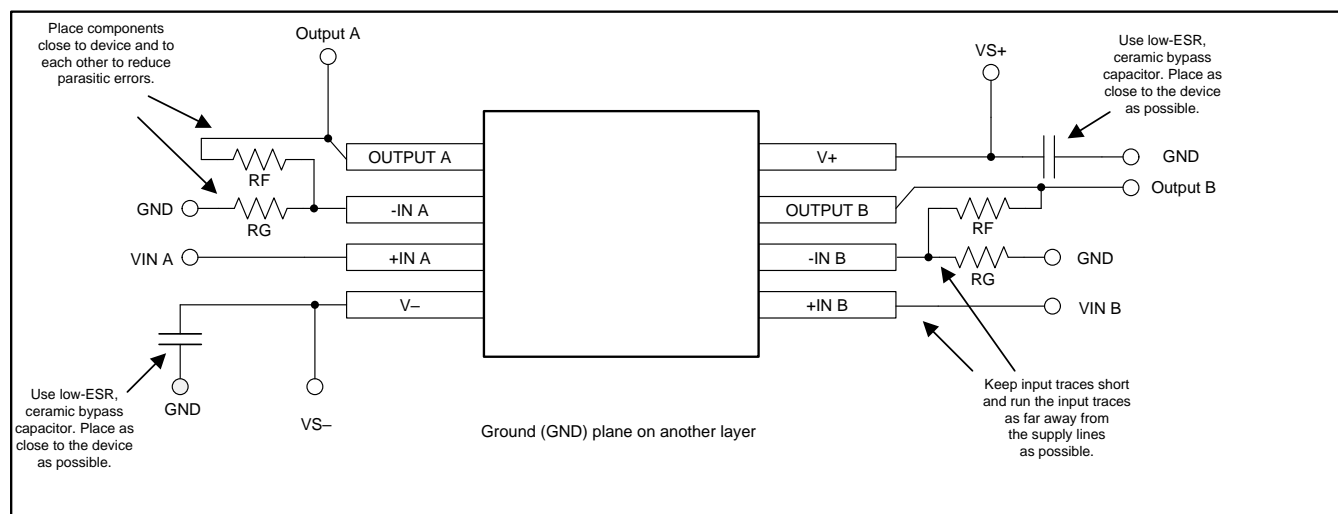
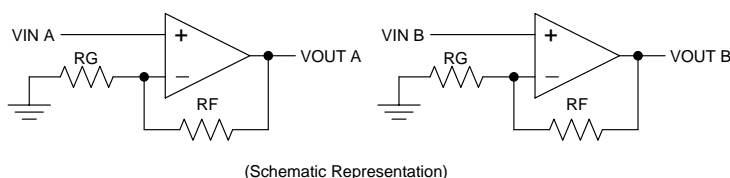


图 42. Operational Amplifier Board Layout for Noninverting Configuration

10.3 Power Dissipation

The OPA167x series op amps are capable of driving 2-k Ω loads with a power-supply voltage up to ± 18 V and full operating temperature range. Internal power dissipation increases when operating at high supply voltages. Copper leadframe construction used in the OPA167x series op amps improves heat dissipation compared to conventional materials. Circuit board layout can also help minimize junction temperature rise. Wide copper traces help dissipate the heat by acting as an additional heat sink. Temperature rise can be further minimized by soldering the devices to the circuit board rather than using a socket.

11 器件和文档支持

11.1 器件支持

11.1.1 开发支持

11.1.1.1 TINA-TI™ (免费软件下载)

TINA™是一款简单、功能强大且易于使用的电路仿真程序，此程序基于 SPICE 引擎。TINA-TI™ 是 TINA 软件的一款免费全功能版本，除了一系列无源和有源模型外，此版本软件还预先载入了一个宏模型库。TINA-TI 提供所有传统的 SPICE 直流、瞬态和频域分析以及其他设计功能。

TINA-TI 可供[免费下载](#)（位于 WEBENCH®设计中心），并且可提供广泛的后处理功能，允许用户以各种方式设置结果的格式。虚拟仪器提供选择输入波形和探测电路节点、电压和波形的功能，从而创建一个动态的快速入门工具。

注

这些文件需要安装 TINA 软件（由 DesignSoft™提供）或者 TINA-TI 软件。请从 [TINA-TI 文件夹](#) 中下载免费的 TINA-TI 软件。

11.1.1.2 DIP 适配器 EVM

DIP 适配器 EVM 工具提供了一种针对小型表面贴装器件进行原型设计的简易低成本方法。该评估工具适用于以下 TI 封装：D 或 U (SOIC-8)、PW (TSSOP-8)、DGK (VSSOP-8)、DBV (SOT-23-6、SOT-23-5 和 SOT-23-3)、DCK (SC70-6 和 SC70-5) 和 DRL (SOT563-6)。DIP 适配器 EVM 也可搭配引脚排使用或直接与现有电路相连。

11.1.1.3 通用运算放大器评估模块 (EVM)

通用运放 EVM 是一系列通用空白电路板，可简化采用各种器件封装类型的电路板原型设计。借助评估模块电路板设计，可以轻松快速地构造多种不同电路。共有 5 个模型可供选用，每个模型都对应一种特定封装类型。支持 PDIP、SOIC、VSSOP、TSSOP 和 SOT-23 封装。

注

这些电路板均为空白电路板，用户必须自行提供相关器件。TI 建议您在订购通用运算放大器 EVM 时申请几个运算放大器器件样品。

11.1.1.4 TI 高精度设计

TI 高精度设计的模拟设计方案是由 TI 公司高精度模拟实验室设计应用专家创建的模拟解决方案，提供了许多实用电路的工作原理、组件选择、仿真、完整印刷电路板 (PCB) 电路原理图和布局布线、物料清单以及性能测量结果。欲获取 TI 高精度设计，请访问 <http://www.ti.com.cn/www/analog/precision-designs/>。

11.1.1.5 WEBENCH®滤波器设计器

WEBENCH® 滤波器设计器是一款简单、功能强大且便于使用的有源滤波器设计程序。WEBENCH 滤波设计器，用户可使用精选 TI 运算放大器和 TI 供应商合作伙伴提供的无源组件来打造最佳滤波器设计方案。

WEBENCH® 设计中心以基于网络的工具形式提供 WEBENCH® 滤波器设计器。用户通过该工具可在短时间内完成多级有源滤波器解决方案的设计、优化和仿真。

11.2 文档支持

11.2.1 相关文档

使用 OPA167x 时，建议参考下列相关文档。所有这些文档都可从 www.ti.com.cn 上下载（除非另有说明）。

- 德州仪器 (TI)，《放大器源电阻和噪声注意事项》技术简介
- Burr Brown，《运算放大器的单电源运行》应用简报
- Burr Brown，《运算放大器性能分析》应用简报
- 德州仪器 (TI)，《用直观方式补偿跨阻放大器》应用报告

文档支持 (接下页)

- Burr Brown, 《放大器调优》应用简报
- Burr Brown, 《反馈曲线图定义运算放大器交流性能》应用简报
- 德州仪器 (TI), 《适用于专业音频的有源音量控制》精密设计

11.3 相关链接

下表列出了快速访问链接。类别包括技术文档、支持和社区资源、工具和软件，以及立即订购快速访问。

表 2. 相关链接

器件	产品文件夹	立即订购	技术文档	工具与软件	支持和社区
OPA1678	单击此处	单击此处	单击此处	单击此处	单击此处
OPA1679	单击此处	单击此处	单击此处	单击此处	单击此处

11.4 接收文档更新通知

如需接收文档更新通知，请访问 [Ti.com.cn](http://ti.com.cn) 上的器件产品文件夹。单击右上角的通知我 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查阅已修订文档中包含的修订历史记录。

11.5 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.6 商标

TINA-TI, E2E are trademarks of Texas Instruments.
WEBENCH is a registered trademark of Texas Instruments.
TINA, DesignSoft are trademarks of DesignSoft, Inc.
All other trademarks are the property of their respective owners.

11.7 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

11.8 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请查阅左侧的导航栏。

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
OPA1678IDGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	1AW7	Samples
OPA1678IDGKT	ACTIVE	VSSOP	DGK	8	250	RoHS & Green	NIPDAUAG	Level-2-260C-1 YEAR	-40 to 85	1AW7	Samples
OPA1678IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	OP1678	Samples
OPA1678IDRGR	ACTIVE	SON	DRG	8	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	OP1678	Samples
OPA1678IDRGT	ACTIVE	SON	DRG	8	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	OP1678	Samples
OPA1679IDR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	OPA1679	Samples
OPA1679IPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	OPA1679	Samples
OPA1679IRUMR	ACTIVE	WQFN	RUM	16	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1679	Samples
OPA1679IRUMT	ACTIVE	WQFN	RUM	16	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	OPA 1679	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF OPA1679 :

- Automotive : [OPA1679-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA1678IDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA1678IDGKT	VSSOP	DGK	8	250	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
OPA1678IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA1678IDRGR	SON	DRG	8	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA1678IDRGT	SON	DRG	8	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
OPA1679IDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
OPA1679IPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
OPA1679IRUMR	WQFN	RUM	16	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
OPA1679IRUMT	WQFN	RUM	16	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA1678IDGKR	VSSOP	DGK	8	2500	366.0	364.0	50.0
OPA1678IDGKT	VSSOP	DGK	8	250	366.0	364.0	50.0
OPA1678IDR	SOIC	D	8	2500	853.0	449.0	35.0
OPA1678IDRGR	SON	DRG	8	3000	367.0	367.0	35.0
OPA1678IDRGT	SON	DRG	8	250	210.0	185.0	35.0
OPA1679IDR	SOIC	D	14	2500	853.0	449.0	35.0
OPA1679IPWR	TSSOP	PW	14	2000	853.0	449.0	35.0
OPA1679IRUMR	WQFN	RUM	16	3000	367.0	367.0	35.0
OPA1679IRUMT	WQFN	RUM	16	250	210.0	185.0	35.0

GENERIC PACKAGE VIEW

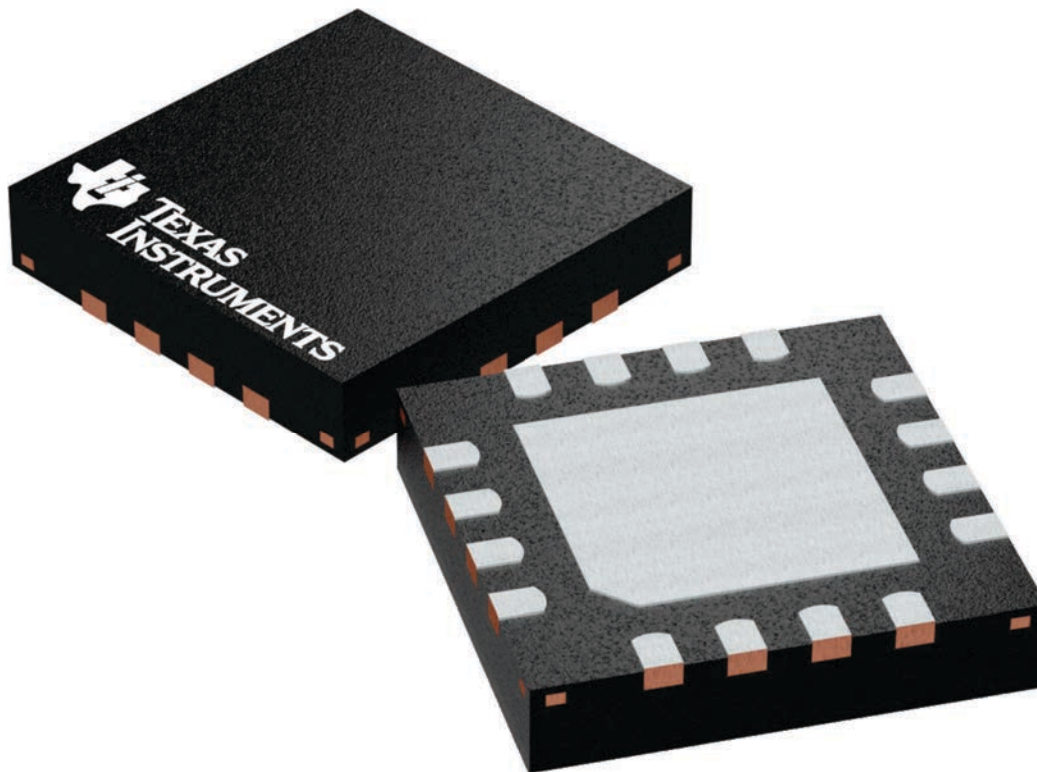
RUM 16

WQFN - 0.8 mm max height

4 x 4, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

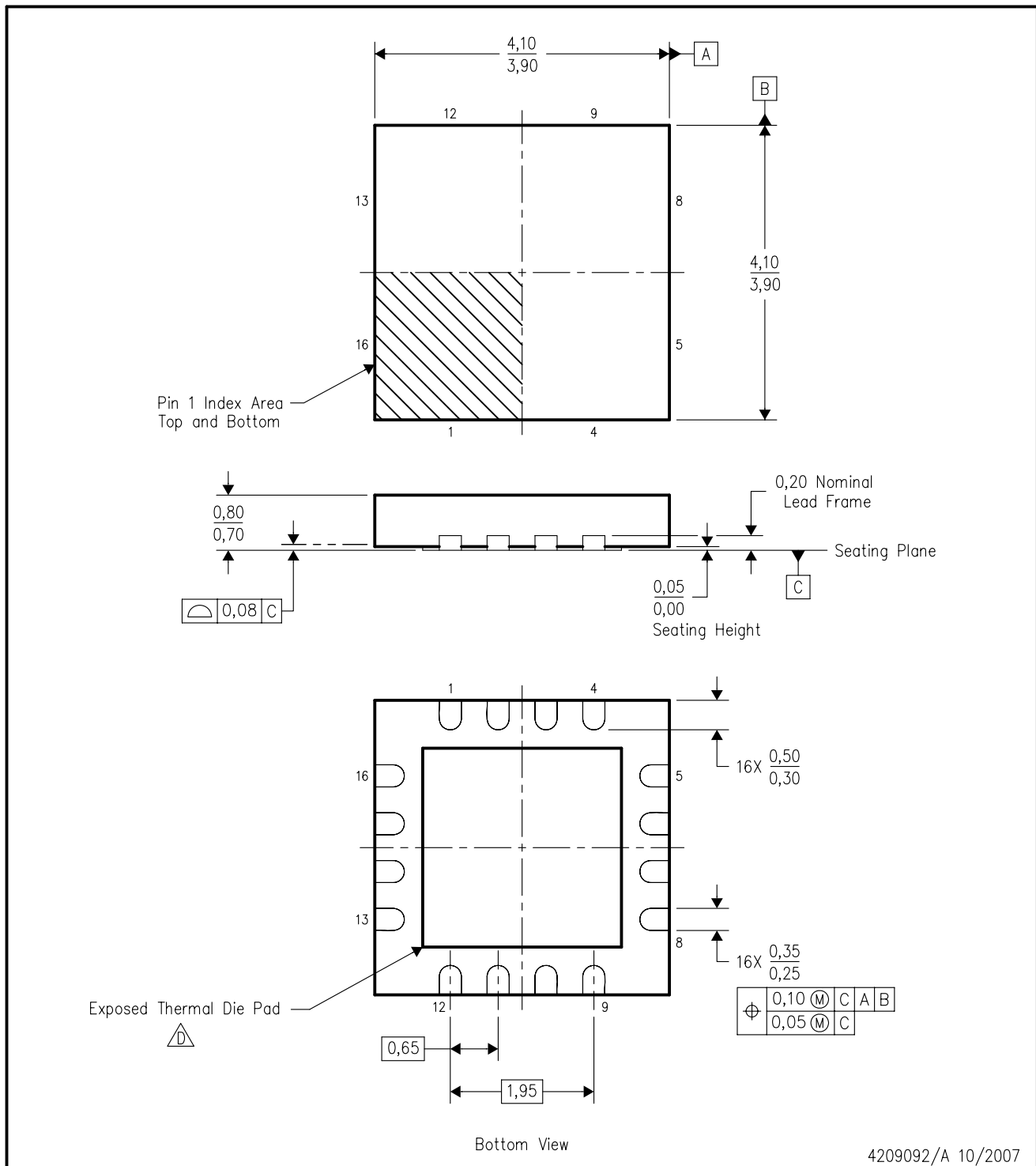
This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224843/A

RUM (S-PQFP-N16)

PLASTIC QUAD FLATPACK



4209092/A 10/2007

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - QFN (Quad Flatpack No-Lead) package configuration.
 - The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
 - Package complies to JEDEC MO-220 variation WGGC-3.

RUM (S-PWQFN-N16)

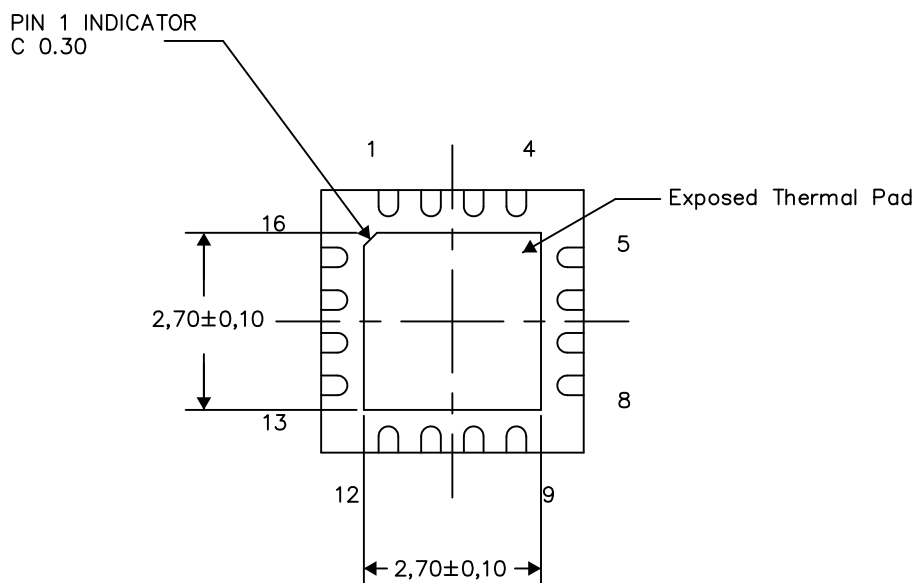
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

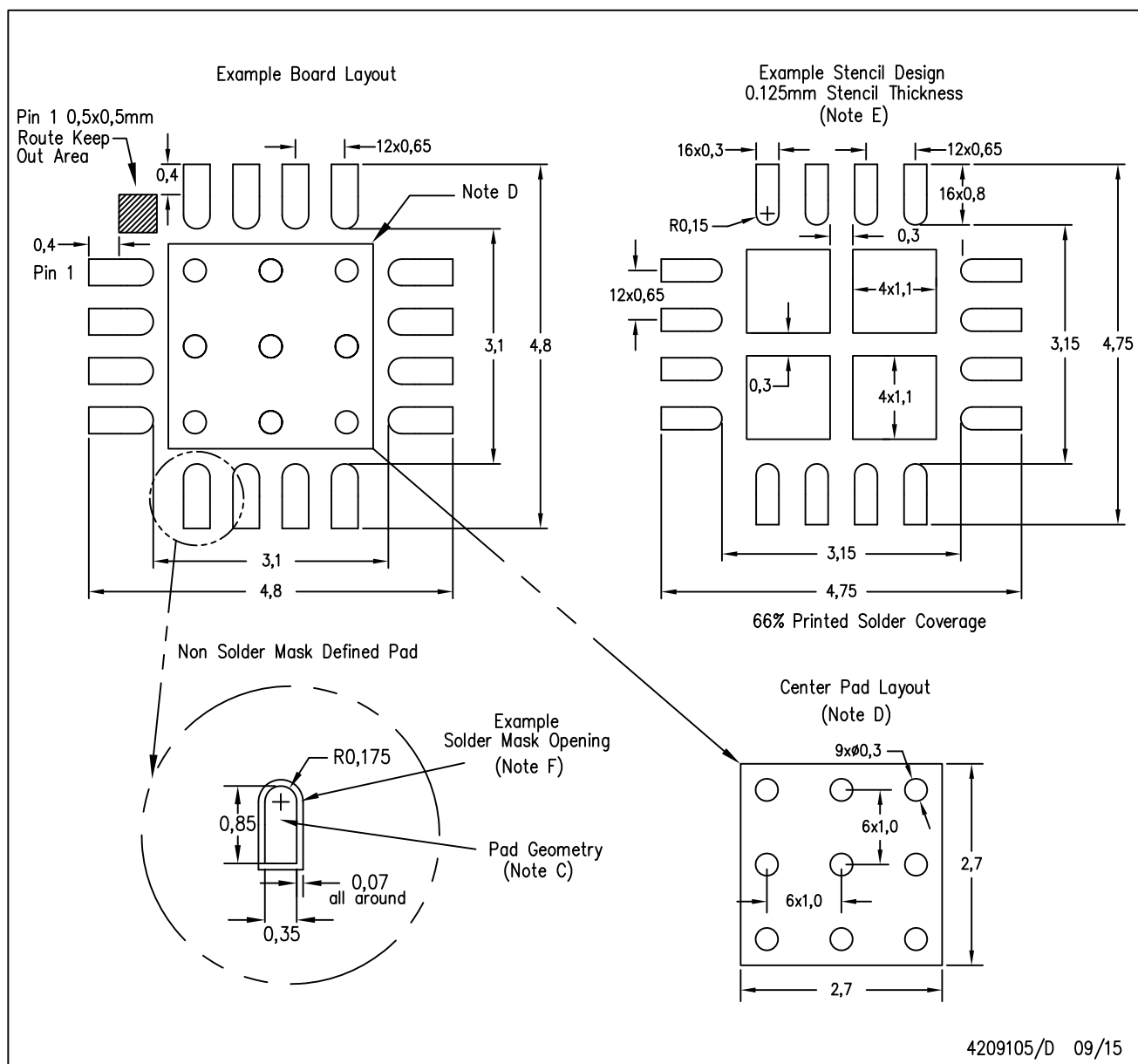
Exposed Thermal Pad Dimensions

4209093-2/F 09/15

NOTES: All linear dimensions are in millimeters

RUM (S-PWQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - Customers should contact their board fabrication site for solder mask tolerances.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4040047-5/M 06/11

NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



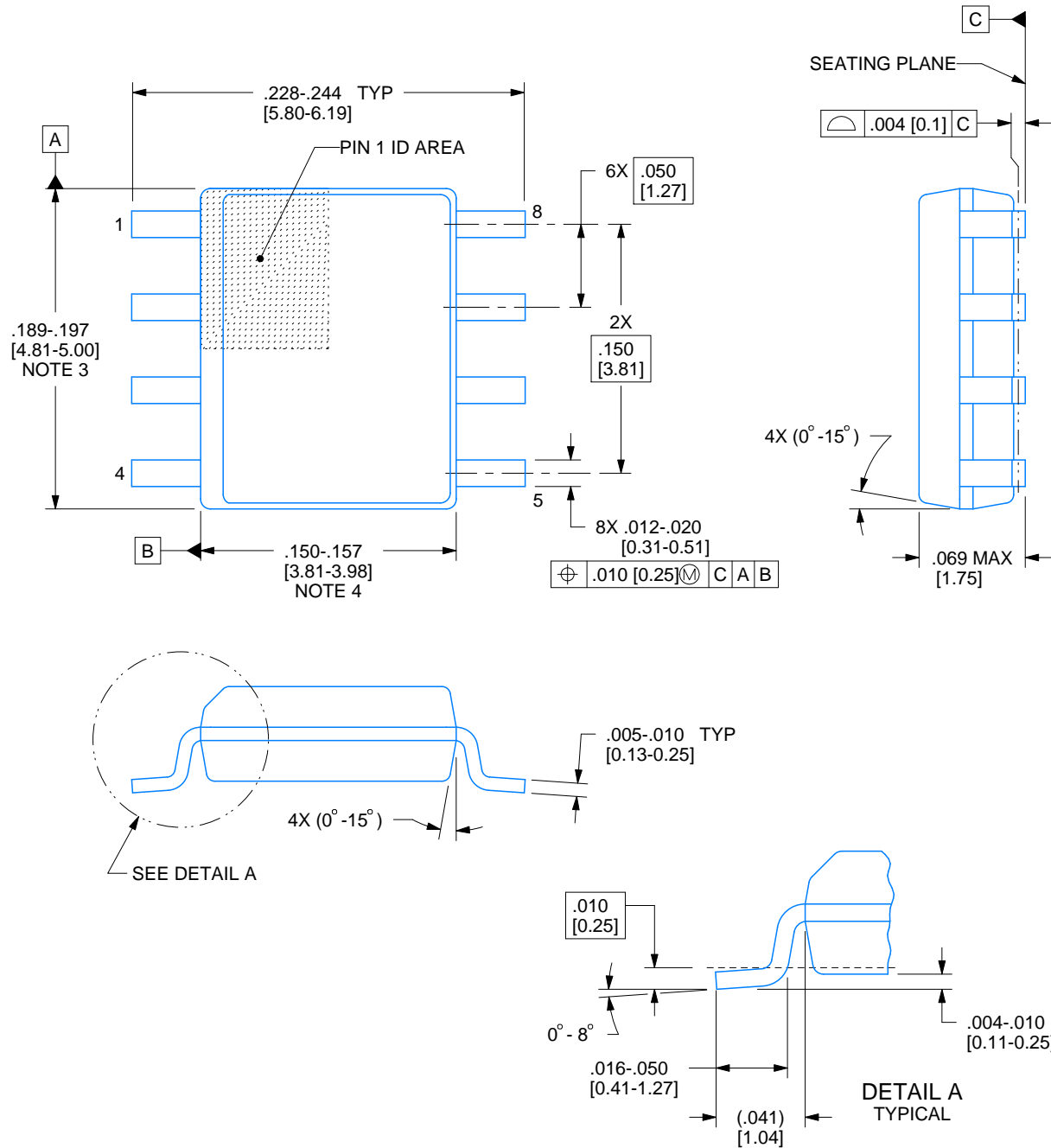
- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

D0008A

PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

DGK (S-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 per end.
- D. Body width does not include interlead flash. Interlead flash shall not exceed 0.50 per side.
- E. Falls within JEDEC MO-187 variation AA, except interlead flash.

DGK (S-PDSO-G8)

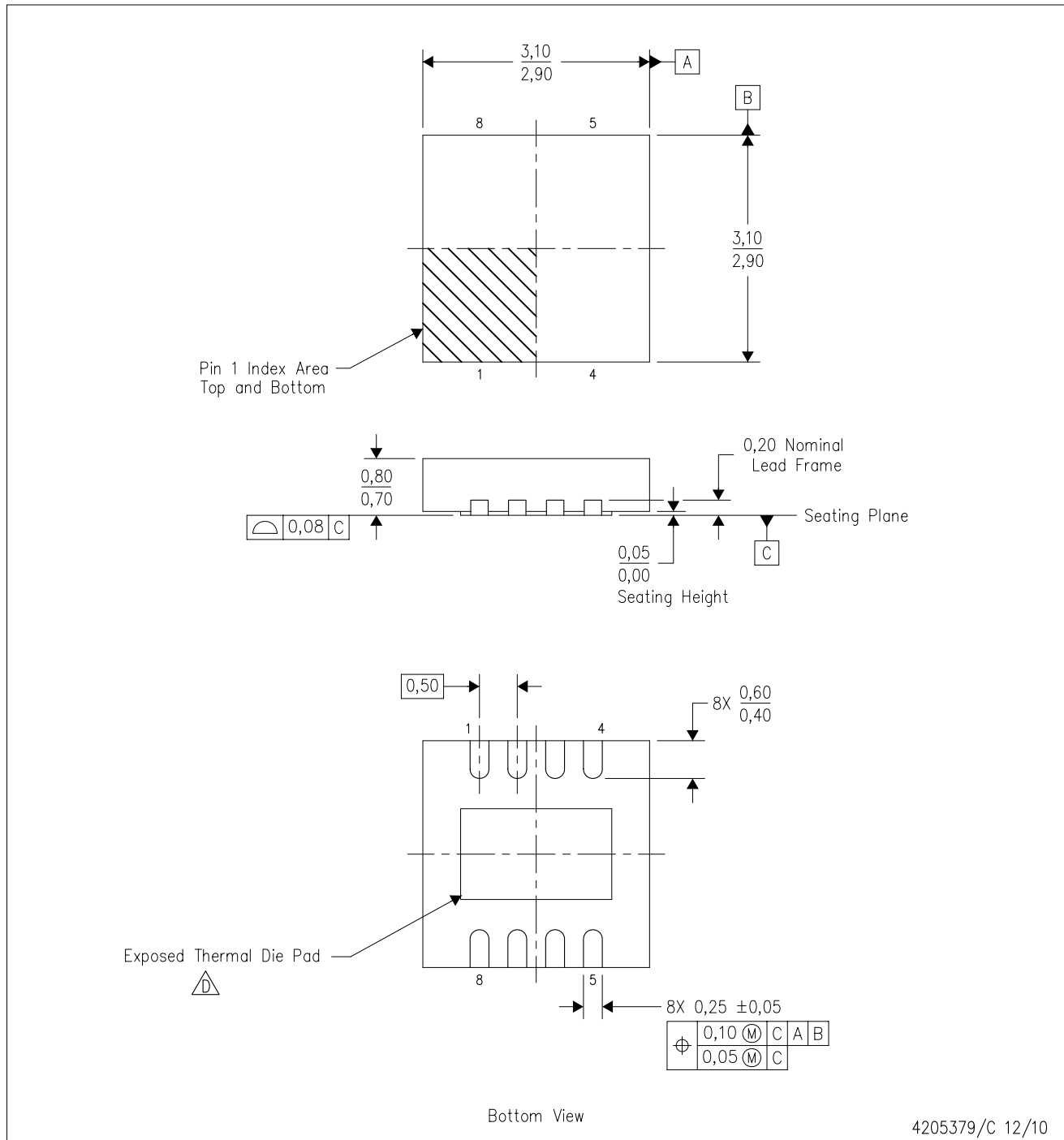
PLASTIC SMALL OUTLINE PACKAGE



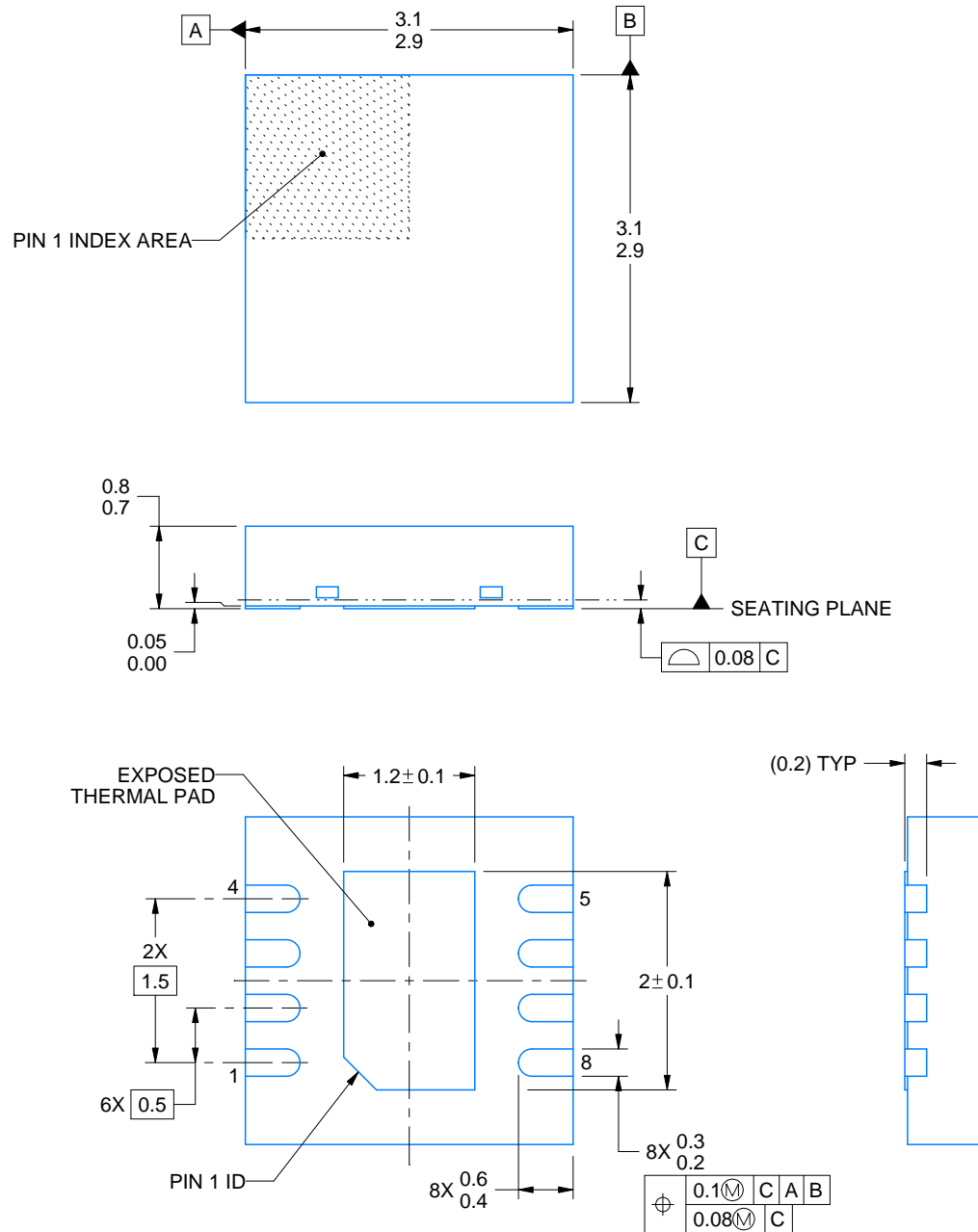
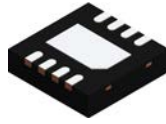
- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

DRG (S-PWSON-N8)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. SON (Small Outline No-Lead) package configuration.
 - D. The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
 - E. JEDEC MO-229 package registration pending.



4218885/A 03/2020

NOTES:

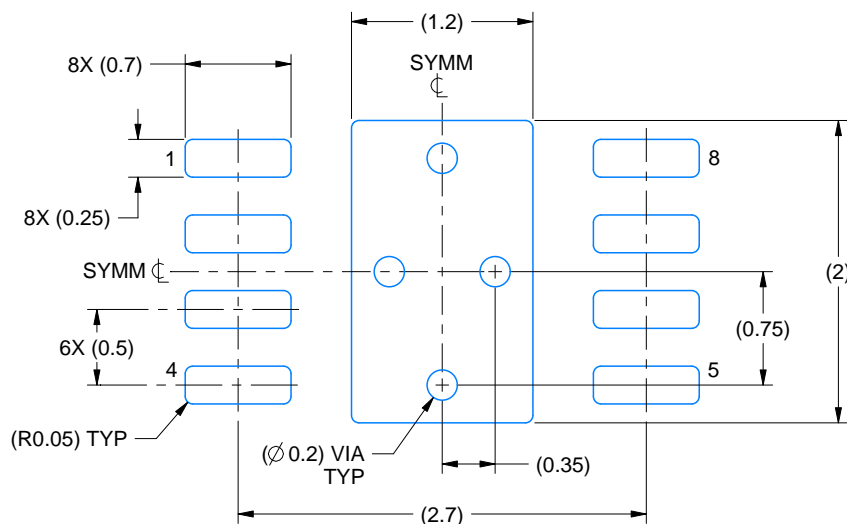
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

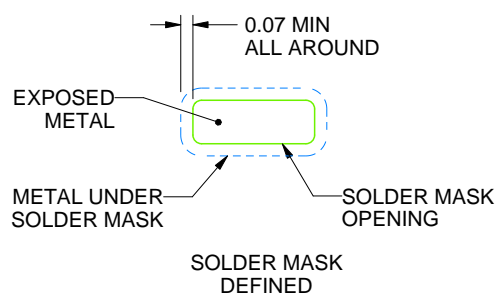
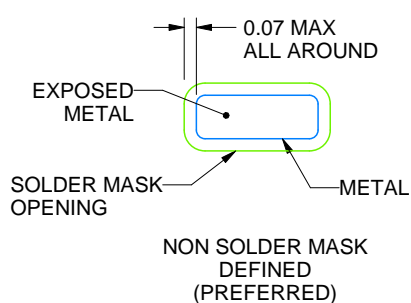
DRG0008A

WSN - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:20X



SOLDER MASK DETAILS

4218885/A 03/2020

NOTES: (continued)

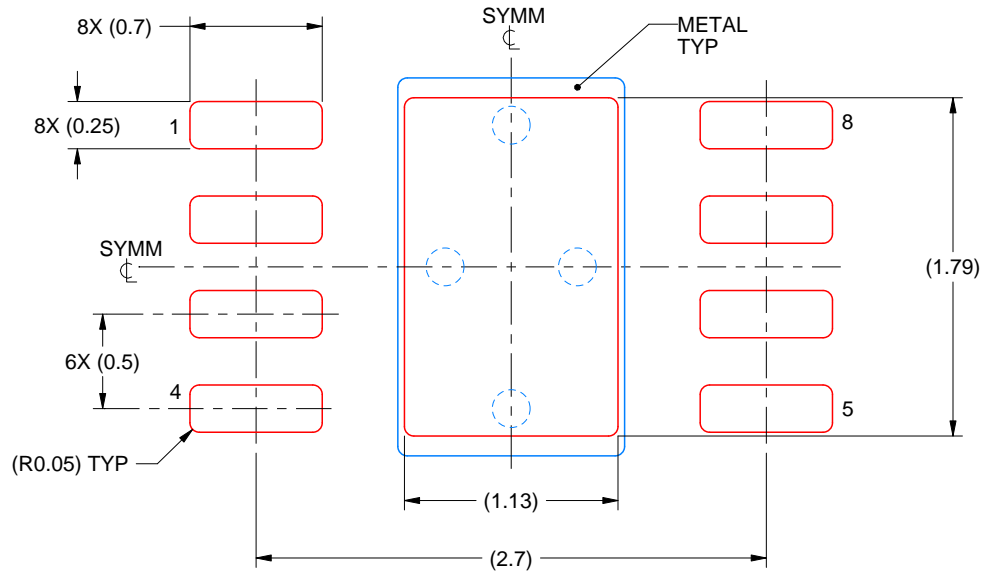
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

DRG0008A

WSO - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
84% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4218885/A 03/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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